HIOKI

Instruction Manual

ST5520 ST5520-01 INSULATION TESTER

HIOKI E.E. CORPORATION

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Introduction

Thank you for choosing the HIOKI ST5520/ST5520-01 Insulation Tester. To obtain maximum performance from the product, please read this manual first, and keep it handy for future reference.

The ST5520-01 is equipped with the BCD output function of the ST5520. The artwork of the ST5520 is used in this manual.

Verifying Package Contents

When you receive the instrument, inspect it carefully to ensure that no damage occurred during shipping. In particular, check the accessories, panel switches, and connectors. If damage is evident, or if it fails to operate according to the specifications, contact your authorized Hioki distributor or reseller.

Check the package contents as follows.

ST5520 or ST5520-01		Power cord1
Insulation Tester	.1	
HIOKI WANTED		
		Instruction Manual1
		EXT.I/O connector (pin contacts)1
		EXT.I/O connector cover1 set

Verifying Package Contents

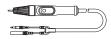
Options

The following options are available for ST5520/ST5520-01. Contact your authorized Hioki distributor or reseller when ordering.

☐ L2200 Test Lead



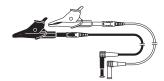
☐ 9299 Switched Probe



☐ 9637 RS-232C Cable (9pin-9pin/1.8 m)



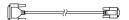
☐ L9257 Connection Cord



☐ 9094 Output Cord (analog output)



☐ 9638 RS-232C Cable (9pin-25pin/1.8 m)



Safety Notes

This instrument is designed to conform to IEC 61010 Safety Standards, and has been thoroughly tested for safety prior to shipment. However, using the instrument in a way not described in this manual may negate the provided safety features.

Before using the instrument, be certain to carefully read the following safety notes.

⚠DANGER



Mishandling during use could result in injury or death, as well as damage to the instrument. Be certain that you understand the instructions and precautions in the manual before use.

MARNING



With regard to the electricity supply, there are risks of electric shock, heat generation, fire, and arc discharge due to short circuits. If persons unfamiliar with electricity measuring instruments are to use the instrument, another person familiar with such instruments must supervise operations.

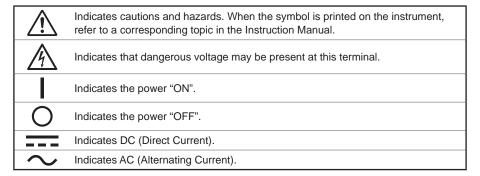
Safety Notes

Notation

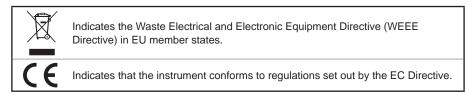
In this manual, the risk seriousness and the hazard levels are classified as follows.

⚠ DANGER	Indicates an imminently hazardous situation that will result in death or serious injury to the operator.
MARNING	Indicates a potentially hazardous situation that may result in death or serious injury to the operator.
∆CAUTION	Indicates a potentially hazardous situation that may result in minor or moderate injury to the operator or damage to the instrument or malfunction.
IMPORTANT	Indicates information related to the operation of the instrument or maintenance tasks with which the operators must be fully familiar.
A	Indicates a high voltage hazard. If a particular safety check is not performed or the instrument is mishandled, this may give rise to a hazardous situation; the operator may receive an electric shock, may get burnt or may even be fatally injured.
\Diamond	Indicates prohibited actions.
0	Indicates the action which must be performed.
*	Additional information is presented below.
[]	Indicates set items and buttons on the display in [].
SET (Boldface)	Bold-faced alphanumeric characters in the text indicate characters shown on the operation keys.

Symbols affixed to the instrument



Symbols for various standards



Accuracy

We define measurement tolerances in terms of f.s. (full scale), rdg. (reading), and dgt. (digit) values, with the following meanings:

f.s.	(Maximum display value, scale length) The maximum display value or the full length of the scale. This is usually the maximum value of the currently selected range.
rdg.	(Reading or displayed value) The value currently being measured and indicated on the measuring instrument.
dgt.	(Resolution) The smallest displayable unit on a digital measuring instrument, i.e., the input value that causes the digital display to show a "1" as the least-significant digit.

Measurement categories

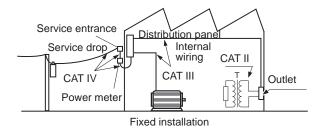
To ensure safe operation of measuring instruments, IEC 61010 establishes safety standards for various electrical environments, categorized as CAT II to CAT IV, and called measurement categories.

↑ DANGER

 Using a measuring instrument in an environment designated with a higher-numbered category than that for which the instrument is rated could result in a severe accident, and must be carefully avoided.



- Using a measuring instrument without categories in an environment designated with the CAT II to CAT IV category could result in a severe accident, and must be carefully avoided.
- CAT II: When directly measuring the electrical outlet receptacles of the primary electrical circuits in equipment connected to an AC electrical outlet by a power cord (portable tools, household appliances, etc.)
- CAT III: When measuring the primary electrical circuits of heavy equipment (fixed installations) connected directly to the distribution panel, and feeders from the distribution panel to outlets
- CAT IV: When measuring the circuit from the service drop to the service entrance, and to the power meter and primary overcurrent protection device (distribution panel)



Usage Notes

Follow these precautions to ensure safe operation and to obtain the full benefits of the various functions.

Preliminary checks

A DANGER

If the probe or the instrument is damaged, there is a risk of electric shock. Before using the instrument, perform the following inspection.



- Before using the instrument, check that the coating of the probes are neither ripped nor torn and that no metal parts are exposed.
 Using the instrument under such conditions could result in electric shock. Replace the probes with those specified by our company.
- Before using the instrument the first time, verify that it operates normally to ensure that no damage occurred during storage or shipping. If you find any damage, contact your authorized Hioki distributor or reseller.

Installation

Installing the instrument in inappropriate locations may cause a malfunction of instrument or may give rise to an accident. Avoid the following locations. For details on the operating temperature and humidity, refer to the specifications. (p.147)

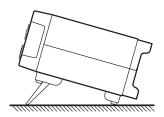
ACAUTION

- · Exposed to direct sunlight or high temperature
- · Exposed to corrosive or combustible gases



- · Exposed to water, oil, chemicals, or solvents
- Exposed to high humidity or condensation
- Exposed to high quantities of dust particles
- · Susceptible to vibration

Installation precaution



ACAUTION



Do not position the instrument on an unstable table or inclined surface. If the instrument falls or tips, a malfunction of the instrument or injury may be caused.

Handling the instrument

MDANGER



To avoid electric shock, do not remove the instrument's case. The internal components carry high voltage and high temperature.

WARNING



Customers are not allowed to modify, disassemble, or repair the instrument. Doing so may cause fire, electric shock, or injury.

ACAUTION



- To avoid damage to the instrument, protect it from vibrations and physical shock when transporting and handling. Be especially careful to avoid physical shock from dropping.
- To avoid damage to the instrument, do not apply voltage or current to EXT.SW terminal, analog output terminal, or maintenance terminal.

This instrument may cause interference if used in residential areas. Such use must be avoided unless the user takes special measures to reduce electromagnetic emissions to prevent interference to the reception of radio and television broadcasts.

Handling the cords and leads





To avoid electric shock, be careful to avoid shorting live lines with the test leads.

MARNING



Before using the instrument, check that the coating of the cords are not either ripped or torn and that no metal parts are exposed. If any damage is found, contact your authorized Hioki distributor or reseller to prevent electric shock.

ACAUTION

- To avoid damage to the instrument, do not short connectors or output components or input voltage.
- To avoid damage to the instrument, do not apply voltage or current to the analog output terminal or EXT.SW terminal.



- Avoid stepping on or pinching the cables, which could damage the cable insulation.
- To avoid breaking cables or lead wires, do not bend or pull them at the base.
- Bare conductors could be exposed if the insulation melts. Do not touch the heat sources.

To avoid electric shock and damage to the instrument, observe the cautions listed below when connecting the analog output terminal, RS-232C connector, and EXT.I/O terminal.

- Always turn off the power on the instrument and on any devices to be connected before making connections.
- Be careful to avoid exceeding the rating of the analog output terminal, RS-232C connector, or EXT.I/O terminal signal.



- During operation, a wire becoming dislocated and contacting another conductive object can cause serious hazard. Use screws to secure the external connectors.
- Properly isolate the devices and equipment to which the analog output terminal, RS-232C connector, and EXT.I/O terminal are connected.
- To avoid damaging the cord, grasp the plug, not the cord, when unplugging the output connector.
- The cables can become hard in the environment at a temperature of 0°C or lower. When the cables are bent or pulled, the coating of the cables may become damaged or may break.

IMPORTANT

When using the instrument, be sure to use the connecting lead wires, etc. specified by our company. When other cords and lead wires are used, accurate measurement may not be possible because the connection becomes poor, etc.

Before connecting the power cord

⚠WARNING



- To avoid electric shock and to maintain the safety specifications of this instrument, connect the power cord provided only to a 3-contact (two-conductor + ground) outlet.
- Use only the designated power cord with this instrument. Use of other power cords may cause fire.

ACAUTION



To avoid damaging the power cord, grasp the plug, not the cord, when unplugging it from the power outlet.

IMPORTANT

Turn off the power before disconnecting the power cord.

Before connecting measurement leads

<u>∧</u>DANGER



To avoid electric shock and short circuit accidents, turn off all power of the measurement target before connecting measurement leads.

⚠WARNING



To avoid electrical accidents, use the designated wires or ones with more than enough dielectric strength and current capacity.

UL1032 AWG18

Twisted wires 75 wires \times ϕ 0.12 mm

Before connecting switched probes





To avoid damage to the probes, do not bend or pull the probe base.



To ensure safe operation, use only the probes specified by our company.

Residual risk

MARNING



The test leads generate high voltage. To avoid electric shock, do not touch the metal ends of the test leads.

ACAUTION



The ends of the probes are sharp. Be careful to avoid injury.

Before connecting data cables

MARNING



- Failure to fasten the connectors properly may result in subspecification performance or damage to the equipment.
- Always turn off both devices when connecting and disconnecting an interface connector. Otherwise, an electric shock accident may occur.

Before switching between current sink (NPN) and current source (PNP)

ACAUTION



Do not operate the EXT.I/O mode switch (NPN/PNP) while the instrument is on.



Configure the NPN/PNP setting to accommodate externally connected equipment.

Before connecting EXT.I/O

↑ WARNING



External power cannot be supplied to the instrument's EXT.I/O connector. Do not apply external power. (The ISO_5V pin of the EXT. I/O connector is a 5 V (NPN)/-5 V (PNP) power output.)

To avoid electric shock or damage to the equipment, always observe the following precautions when connecting to the EXT.I/O connector.



- Always turn off the main power switch on the instrument and on any devices to be connected before making connections.
- Be careful to avoid exceeding the ratings of external terminals.
 (p.155) During operation, a wire becoming dislocated and contacting another conductive object can cause serious hazard.
 Use screws to secure the external connectors.

ACAUTION



To avoid damage to the instrument, observe the following cautions:

• Do not short circuit ISO_5V and ISO_COM.



 When connecting the relay coil to the EXT.I/O output terminal, be sure to install diodes to absorb current-electromotive force.

Before turning the power on

MARNING



 While insulation resistance is being measured or the START key is pressed, hazardous voltage may be generated in the measurement terminal. To avoid electric shock, do not touch the measurement leads.



 Before turning the instrument on, make sure that the supply voltage matches that indicated on its power connector. Connection to an improper supply voltage may damage the instrument and present electrical hazard.

ACAUTION



 Avoid using an uninterruptible power supply (UPS) or DC/AC inverter with rectangular wave or pseudo-sine-wave output to power the instrument.
 Doing so may damage the instrument.

ACAUTION



- When connecting to the measurement object or not using the instrument, be sure to unplug the power cord from the instrument and completely disconnect it from the power supply for safety.
- Do not connect a wrong power voltage. Doing so may damage the internal circuit.

IMPORTANT

- Turn off the power before disconnecting the power cord.
- To suppress noise, it is necessary to switch the power frequency setting on the instrument. Set the frequency to the frequency of the commercial power supply to be used before starting the measurement.

In the manual setting, a measured value does not stabilize unless the power frequency setting is switched properly.

Precautions during shipment

Observe the following during shipment.

Hioki cannot be responsible for damage that occurs during shipment.

ACAUTION



When shipping the instrument, use the packaging materials used when the instrument is delivered.

Overview

The HIOKI ST5520/ST5520-01 Insulation Tester is an insulation resistance tester that performs insulation resistance testing on components and equipment using direct current voltage.

The test duration is 50 ms at the fastest and high speed testing can be performed. Because this Insulation Tester is equipped with selectable test voltages and EXT.I/O, RS-232C interface, and analog output terminal, it can be used in various fields including production and inspection lines as well as laboratories.

Features

Test duration 50 ms (fastest)

Judgment results can be displayed in 50 ms at the fastest.

Selectable test voltage

The test voltage can be selected from 25 V to 1000 V in increments of a resolution of 1 V. The comparator function (p.44) and test duration function (p.39) support a wide variety of insulation resistance testing according to safety standards.

Easy-to-read display

High definition LCD display for a high level of visibility

Saved setting conditions

Up to ten patterns of test conditions can be saved. When the power is turned on again after it is turned off, the settings before the power is turned off are replicated. (p.76)

External interface

EXT.I/O outputs a signal according to the ST5520/ST5520-01 status. The start/stop signal input and test conditions can be selected. Extended insulation resistance fluctuation can be recorded when analog output is used. (p.81)

Equipped with RS-232C interface

A personal computer (PC) can be connected for automated testing and recording test results. (p.119)

Switched probe

The optional 9299 Switched Probe enables efficient manual testing.

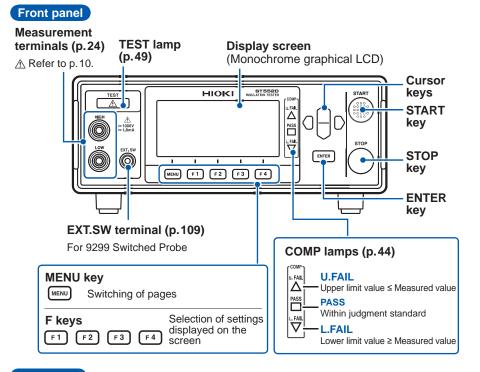
Automatic discharge function

Any charge remaining in pieces of equipment to be measured is released inside the instrument after tests. As the TEST lamp blinks during discharge, the discharge status can be checked.

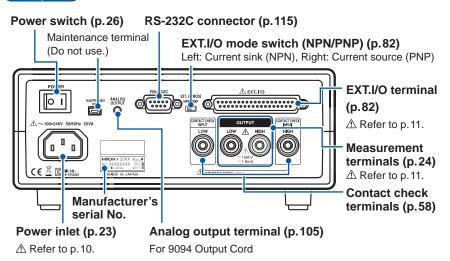
Equipment can be protected from possible damage during successive insulation resistance testing.



1.2 Parts Names and Functions

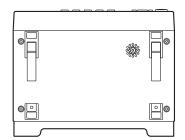


Rear panel



Parts Names and Functions

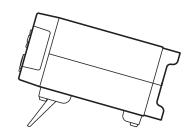
Bottom panel



This instrument can be rack-mounted. Refer to "Appx. 7 Rack Mounting" (p.Appx.10).

The parts removed from this instrument should be stored in a safe place for future reuse.

Side panel



When using the stand

Extend the legs all the way.

Make sure to extend both legs of the stand.

When collapsing the stand

Do not collapse the stand partway. Be sure to collapse it all the way.

ACAUTION



When the instrument is set on the stand, do not apply a strong force from above. Doing so may damage the stand.

1.3 Measurement Workflow

Be sure to refer to "Usage Notes" (p.7) before use.

Preparing for measurement (p.23)

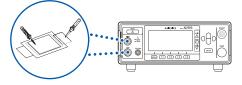


(Use the measurement terminals on the rear panel in case of 4-terminal measurements.)

- Checking before measurement (p.27)
- 3 Setting measurement conditions (p.33)

Item	Description	Reference
Test voltage	Select from 25 V to 1000 V.	p.34
Resistance range	Select either manual range (2 M Ω , 20 M Ω , 200 M Ω , 2000 M Ω , 4000 M Ω) or auto range.	p.36
Measurement speed	Select either FAST or SLOW.	p.38
Test duration	Set the time from when voltage is applied until PASS/FAIL judgment is made (test duration function).	p.39
	Set the response time.	p.41
Comparator (upper/lower limit values)	Set the upper/lower resistance values.	p.44
Test mode	Select from continuous mode, FAIL STOP mode, PASS STOP mode, or forced termination judgment mode.	p.46
Beep sound	Set the conditions to announce the judgment result with a beep sound.	p.47

4 Performing measurement



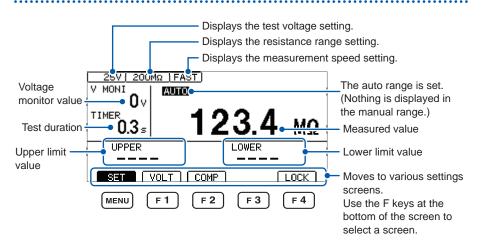
5 Turning off the power after use



1.4 Screen Configuration and Operation Overview

This instrument consists of a measurement screen and various settings screens. The screen examples in this manual appear reversed (black on white) for best visibility. The instrument screens, however, can actually be displayed only as white characters on a black background.

Measurement screen

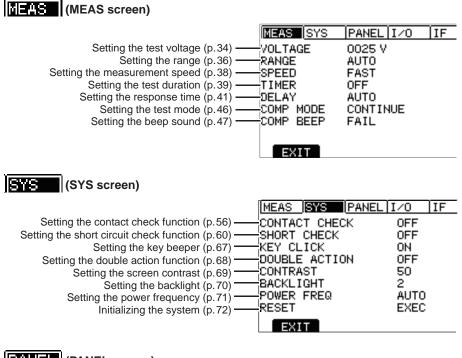


F key set items

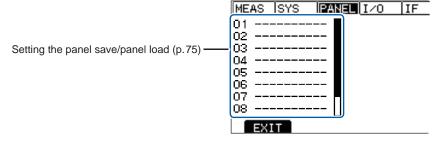
SET	Moves to the Settings screen. (p.33)	
VOLT	Moves to the Test Voltage Settings screen. (p.34)	
COMP	Moves to the Comparator Settings screen. (p.44)	
LOCK	Executes the key lock function. (p.65)	

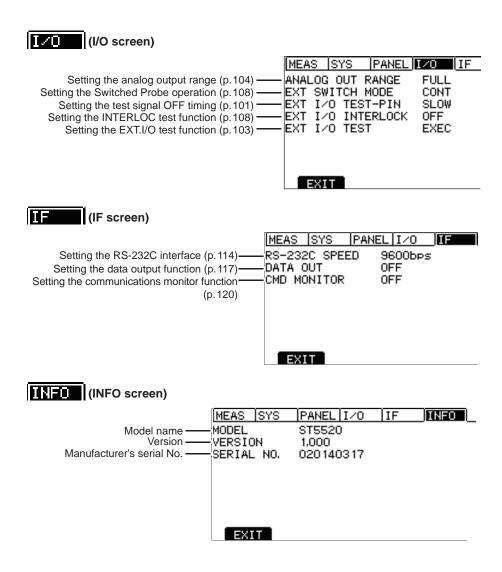


Settings screen



PANEL (PANEL screen)



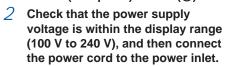


ACAUTION

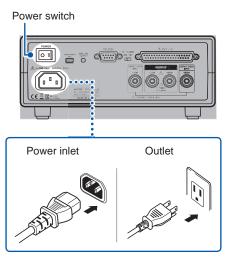
0

To avoid electric shock and short circuits, use the voltage input cord supplied with the instrument.

Check that the instrument power switch (rear panel) is OFF (()).



3 Plug the power cord into the outlet.

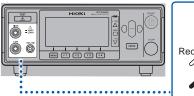


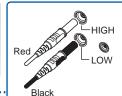
2.2 Connecting the Measurement Leads

Connect the optional Hioki measurement leads to the measurement terminals. Refer to "Options" (p.2) for details.

Use the measurement leads (optional) specified by our company.

Connecting to the measurement terminals on the front panel



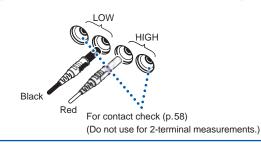


Connect the red plug to the HIGH terminal and the black plug to the LOW terminal.

Connecting to the measurement terminals on the rear panel



Connect the red plug to the inside HIGH terminal and the black plug to the inside LOW terminal. (Do not use the outside terminals on the both ends.)



ACAUTION



When the HIGH terminal is short-circuited to the ground, the voltage of the LOW terminal will become high and it is dangerous for you to touch it. Do not touch the equipment to be measured, measurement leads, HIGH terminals, or LOW terminals during measurement (while the TEST lamp is blinking).

Removing and attaching the sleeves

A CAUTION



The tips of the metal pins are sharp and may cause injury. Do not touch the

The metal tips of the test leads are covered with the removable sleeves. The test leads can be used without the sleeves.

Removing the sleeves

Gently hold the bottom of the sleeves and pull the sleeves off.



Safely store the removed sleeves so as not to lose them.

Attaching the sleeves

Insert the metal pins of the test leads into the holes of the sleeves, and firmly push them all the way in. (Do not touch the tip of the pins.)



2.3 Connecting to the Equipment to be Measured

WARNING

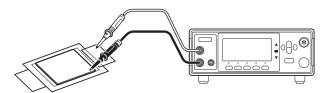


To avoid electric shock and to maintain the safety specifications of this instrument, connect the power cord provided only to a 3-contact (two-conductor + ground) outlet.

IMPORTANT

- Use only the test leads specified by our company with this instrument. When
 other cords are used, accurate measurement may not be possible because the
 connection becomes poor, etc.
- When charged equipment to be measured is connected, the instrument may fail. Connect the test leads after the equipment to be measured is completely discharged.

Example of connection to equipment to be measured



2.4 Turning the Power On and Off

Turning on the power



Turn ON (I) the power switch on the rear panel.

Turning off the power



Turn OFF (O) the power switch on the rear panel.

2.5 Pre-Operation Inspection

Before using the instrument the first time, check that it operates normally to ensure that no damage occurred during storage or shipping. If any damage is found, contact your authorized Hioki distributor or reseller.

Accessory and optional equipment inspection

Check item	Action
Is the power cord coating ripped or torn, or is any metal exposed?	Do not use the instrument if damage is found, as electric shock or short circuit accidents could result. Contact your authorized Hioki distributor or reseller.
Is the probe coating ripped or torn, or is any metal exposed?	Replace the probes with those specified by our company if damage is found, as electric shock could result.

Instrument inspection

Check item	Action
, ,	If damage is found, send out the instrument for repair.

Insulation resistance test inspection

To ensure safe operation of the instrument, check the following before starting measurements.

- Checking the insulation resistance test (p.28)
 Check that the measured resistance matches the resistance value of the prepared resistor.
- Checking the contact check function (p.29)
 Check that the contact check function operates properly.

Checking the insulation resistance test

Required items

Recommended resistor: High voltage high resistance thick film resistor GS series

Manufacturer: KOA Corporation or equivalent

(Be careful with the working voltage and power.)

CAUTION



If the test voltage (power) exceeds the rated voltage (power) of the prepared resistor, the resistor may become damaged.

(Example) When the insulation resistance of the equipment to be measured is 100 M Ω

Maximum working voltage	1000 V
Rated power	0.5 W
Test voltage	500 V

- 7 Prepare a resistor.
- Check that the test voltage is lower than the maximum working voltage of the prepared resistor.

Test voltage < Maximum working voltage of the prepared resistor (Example: 500 V < 1000 V)

3 Check that the value calculated from the test voltage and resistance is smaller than the rated power of the prepared resistor. (If the value calculated from the test voltage and resistance is larger than the rated power of the prepared resistor, change the resistor or the test voltage.)

Squared test voltage \div Resistance < Rated power of the prepared resistor (Example: $\frac{500~V~x~500~V}{100~M\Omega}~=0.0025~W~<0.5~W)$

- 4 Set the test voltage to 500 V.
- 5 Set the lower limit value to 90 MΩ and the upper limit value to 110 MΩ.
- 6 Connect the test leads to the prepared resistor.
- 7 Start a test and check that the measured resistance matches the resistance of the prepared resistor and the comparator judgment result is [PASS].

Checking the contact check function

MARNING



Test leads generate high voltage. To avoid electric shock, do not touch the metal ends of the test leads.

Check that the contact check function operates properly. Check the following three items.

- Checking HIGH side contact (p.30)
- Checking LOW side contact (p.31)
- Checking the operation of the contact check function (p.32)

Checking HIGH terminal contact

To ensure safety, perform the following check with the HIGH side test leads removed. It is recommended to set test conditions as follows.

(Example) When the insulation resistance of the equipment to be measured is 100 M Ω

Test voltage	25 V
Lower limit value	1 ΜΩ
Test duration	10 s

(If the test still starts even under these conditions,

the contact check function may not be [ON] or the

instrument may be damaged.)

(As there is a step to start a tes in the check procedure, set the test voltage low.)

POWER Turn off the instrument power. Connect the test leads to the LOW For contact check · · terminals. (Do not connect the test leads to the HIGH terminals.) Turn on the instrument power. POWER MEAS SYS PANEL I/O Set the contact check function to [ON]. CONTACT CHECK SHORT CHECK KEY CLICK DOUBLE ACTION CONTRAST (p.56)ON BACKLIGHT POWER FREQ RESET Allow the test leads to short circuit. Start a test. Check that a contact error occurs.

30

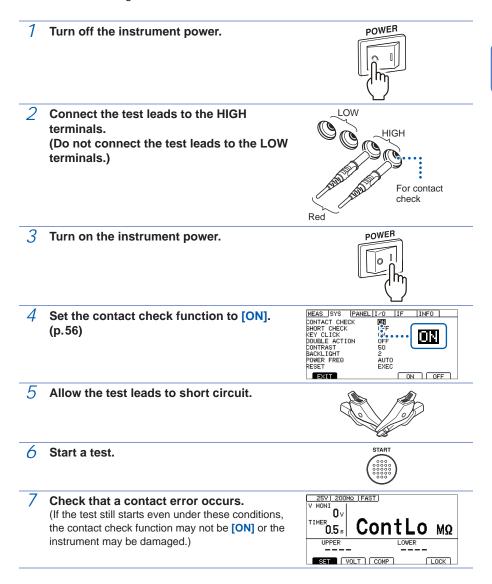
٥v

Sair VOLT COMP

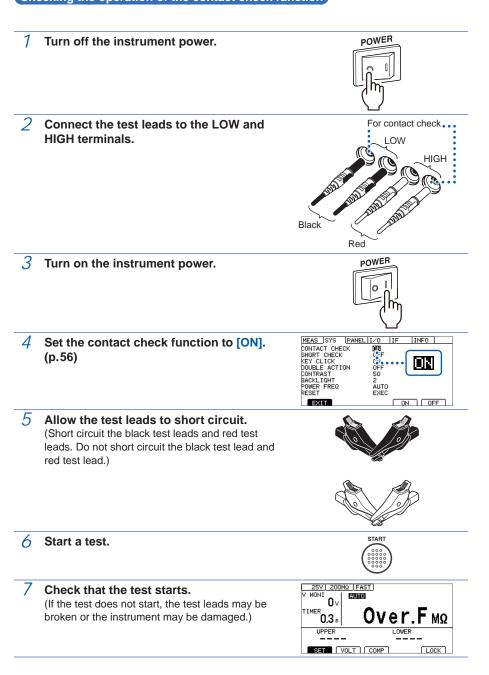
TIMER 0.5 s

Checking LOW side contact

Perform the following check with the LOW terminal test leads removed.



Checking the operation of the contact check function



3 Basic Settings

This chapter describes basic operation settings for the instrument.

"3.1 Setting the Test Voltage"p	.34
"3.2 Setting the Range"	.36
"3.3 Switching the Measurement Speed (FAST/SLOW)"	.38
"3.4 Setting the Test Duration and Response Time"	.39
"Setting the test duration from when voltage is applied until PASS/FAIL judgment is performed" p	.39
"Setting the response time"	.41
"3.5 Judging Measured Values (Comparator function)"	.44
"3.6 Setting the Test Mode"	.46
"3.7 Announcing the Judgment Results Using a Beep Sound"	.47

3.1 Setting the Test Voltage

Set the test voltage between 25 V and 1000 V.

As the measurement range is set based on the test voltage, a measurement range that is not appropriate for the settings is switched automatically. The test voltage can be set in the Measurement or the settings screen.

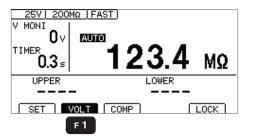
ACAUTION



Setting at improper voltage may damage equipment to be measured.

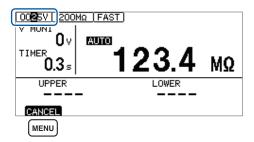
Setting the test voltage in the Measurement screen

1 Select [VOLT].



F 1 Select [VOLT].

Change and then confirm the test voltage value.



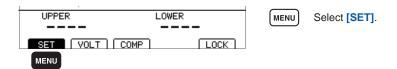
- 4
- Change the value. (Up/Down keys)
- Change the cursor position. (Left and right keys)

ENTER Confirm the value.

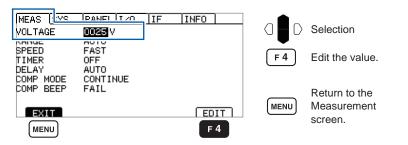
MENU Cancel the change.

Setting the test voltage in the Settings screen

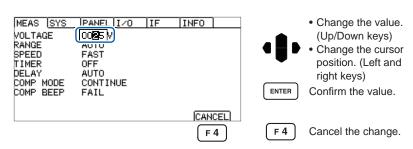
Open the Settings screen.



2 Set [VOLTAGE] to edit mode.



3 Change and then confirm the test voltage value.

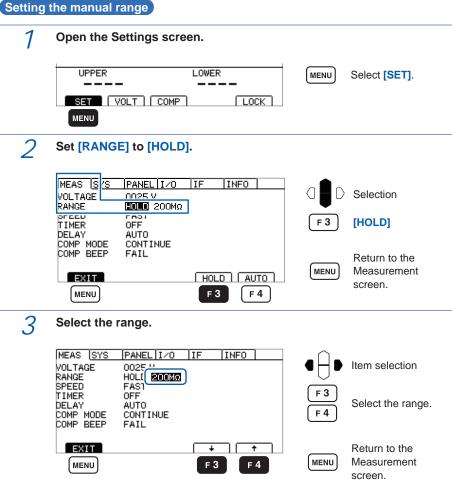


When a voltage that is higher than the set test voltage is output (set voltage + 20%), [Output voltage Error] is displayed on the screen. The test is stopped and no further key operations can be performed. Turn OFF the power switch on the rear panel.

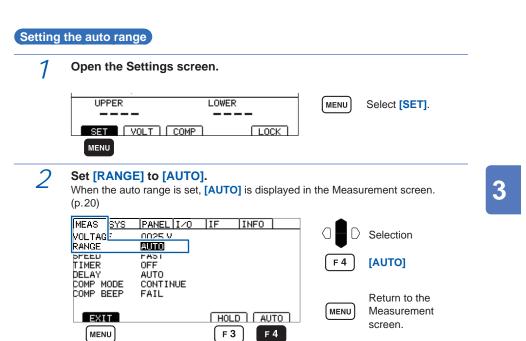
Refer to "10.2 Troubleshooting" (p. 163).

3.2 Setting the Range

There are two range settings, auto and manual. For the manual range setting, the range can be chosen from 2 M Ω , 20 M Ω , 200 M Ω , 2000 M Ω , and 4000 M Ω . Note, however, that the ranges that can be set varies depending on the test voltage. (p. 149) The auto range may require some time before a measured value is displayed as the range has to shift after a test starts. To eliminate this time, set the range manually according to the object to be measured.



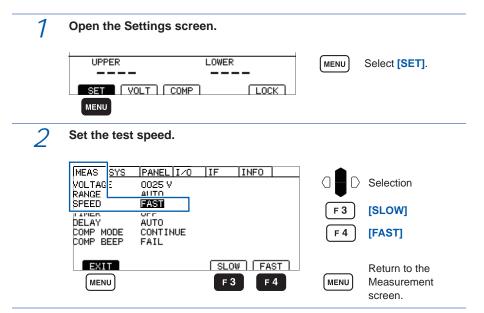
When analog output is used, 0 to 4 V is output from the analog output terminal according to each resistance range. (p. 105)



3.3 Switching the Measurement Speed (FAST/ SLOW)

There are two measurement speeds, **[FAST]** and **[SLOW]**. The resistance is measured and displayed in 30 ms when the measurement speed is set to **[FAST]** and in 500 ms when the speed is set to **[SLOW]**.

Setting the measurement speed to **[SLOW]** is effective if a measured value fluctuates and it is difficult to read the value.



IMPORTANT

- The sampling time is 100 ms even when the measurement speed is set to [FAST] if the contact check function is ON.
 - (The sampling time is 500 ms if the measurement speed is set to **[SLOW]** regardless of the function check setting.)
- If the test duration is set to less than 500 ms when the measurement speed is set to [SLOW], the measured value is not displayed. Set a test duration that is longer than the sampling time.

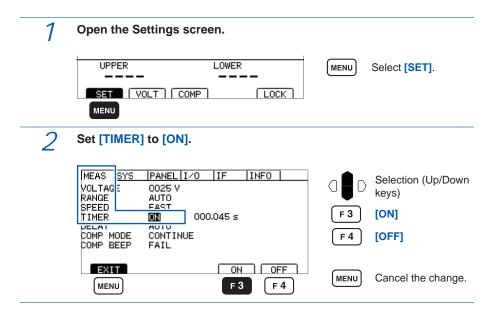
3.4 Setting the Test Duration and Response Time

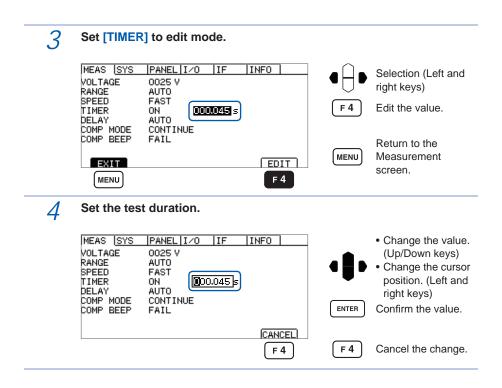
Setting the test duration from when voltage is applied until PASS/FAIL judgment is performed

Test duration is the time to apply voltage, measure resistance, and perform PASS/FAIL judgment. The same test duration is applicable at any test voltage.

IMPORTANT

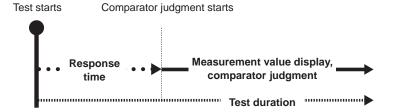
- In the auto range, if the test duration is set to a short time period, a test may
 finish without displaying a measured value because of a range shift. If the auto
 range is used, check the time required for a measured value to stabilize and set
 the test duration.
- The measured resistance can become low over time depending on the equipment to be measured. (Example: When the terminal to ground capacity is large, etc.)
 Setting an improper test duration could result in erroneous judgment. Carefully check the time required for a measured value to stabilize and set the test duration.





Setting the response time

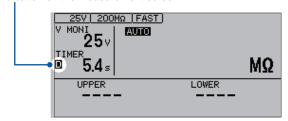
Response time is the time to prohibit comparator judgment after a test starts until the set response time elapses. No measured value is displayed during the response time. The response time is included in the test duration. The same response time is applicable at any test voltage.



3

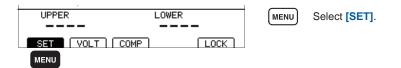
- The response time varies depending on the equipment to be measured.
 If a capacitive load is connected, it may take time for the output voltage to rise
- When the response time is set to [AUTO], the output is monitored and the
 measurement starts after the voltage is stabilized. The time required for the
 voltage to stabilize varies depending on the equipment to be measured.
- If the electrostatic capacity of the equipment to be measured is 1μF or more, the [AUTO] function may not operate properly because it takes time to charge the equipment to be measured. Check the time required for the value on the voltage monitor to reach the set voltage, and then set it after [MANUAL] is selected.
- When the response time is set to [MANUAL], the measurement starts anytime. The measurement may start before the output voltage rises depending on the equipment to be measured. Set the response time according to the equipment to be measured.

During the response time, **[D]** is displayed to the left of the test duration indication on the measurement screen.

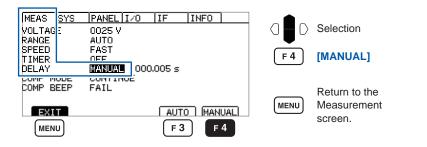


Setting to MANUAL

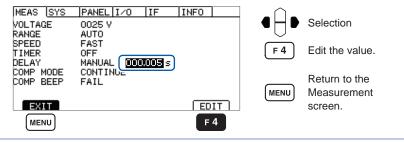
Open the Settings screen.



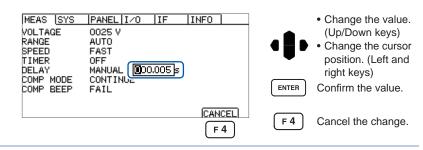
2 Set [DELAY] to [MANUAL].

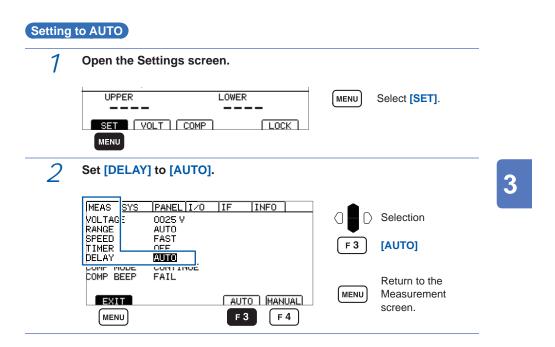


3 Set [DELAY] to edit mode.



Set the response time.

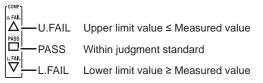




3.5 Judging Measured Values (Comparator function)

The following are enabled with the comparator function.

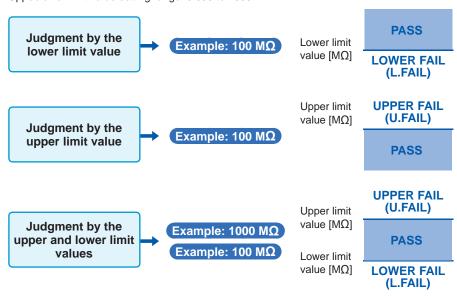
• The instrument displays a judgment result (COMP lamp U.FAIL/PASS/L.FAIL).



- A buzzer sounds (default value FAIL). Refer to "3.7 Announcing the Judgment Results Using a Beep Sound" (p.47).
- A judgment result is externally output.
 Refer to "7 External Control (EXT.I/O)" (p.81).

There are the following three comparator judgment methods.

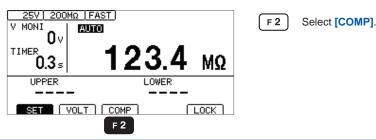
Upper/lower limit value setting range: 0.000 to 4000 $\mbox{M}\Omega$



If the upper and lower limit values are set to values outside of the accuracy range, the U.FAIL and L.FAIL lamps turn on at the same time.

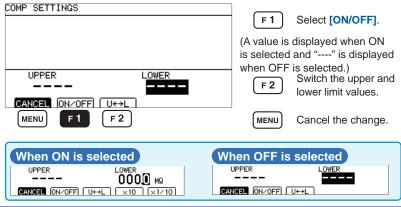




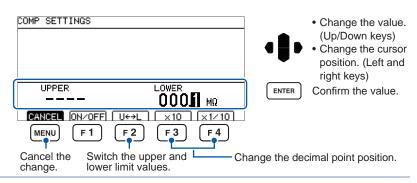


Set the comparator function to [ON].

The comparator function can be set to ON and OFF for each of the upper and lower limit values.



3 Set and confirm the values.

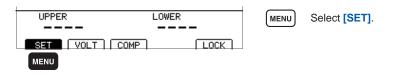


The upper limit value can be set to any value. Set the upper limit value to perform a 2-terminal contact check or when the upper limit value can be estimated.

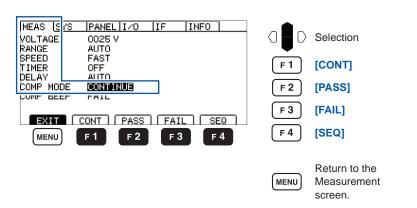
3.6 Setting the Test Mode

There are four test modes: Continuous test, PASS STOP, FAIL STOP, and Forced termination judgment.

Open the Settings screen.



Set the test mode.

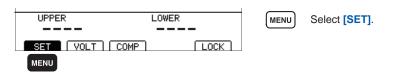


[CONT] (Continuous test mode)	Continues tests until the set test duration elapses and outputs the judgment result every sampling.
[PASS] (PASS STOP mode)	Terminates a test and outputs the judgment result when PASS judgment is made.
[FAIL] (FAIL STOP mode)	Terminates a test and outputs the judgment result when FAIL judgment is made.
[SEQ] (Forced termination judgment mode)	Outputs the judgment result when the set test duration elapses or at the time of STOP input (key, RS-232C command, or EXT.I/O).

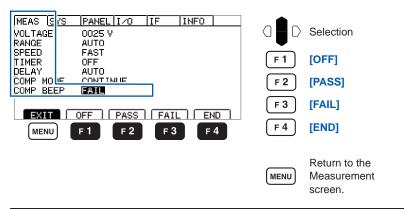
3.7 Announcing the Judgment Results Using a Beep Sound

Judgment results are announced with a beep sound under the four conditions, OFF, PASS, FAIL, and END.

7 Open the Settings screen.



2 Set the conditions for the beep sound.



[OFF]	No beep sound.
[PASS]	Beeps for PASS judgment.
[FAIL]	Beeps for FAIL judgment.
[END]	Beeps when a measurement is completed.

Testing

This chapter describes testing procedures for the instrument.

4.1 Starting Measurements

MARNING

Observe the following to avoid electric shock.

 When the TEST lamp is blinking, do not touch the equipment to be measured, the tip of the probe, and measurement terminals.



- The measurement terminals on the front panel and the corresponding ones on the rear panel are connected each other in the instrument. Do not touch the measurement terminals.
- Do not touch the equipment to be measured, the tip of the probes, and measurement terminals immediately after tests are completed.
 High voltage charge may cause electric shock.



- To avoid electric shock, use the discharge function on the instrument to release charge in pieces of equipmentS to be measured after tests. (p.54)
- 1 Set the measurement items. (p.33)
- Press the START key to start a measurement.



3 The TEST lamp blinks at intervals of 250 ms during measurement.



Starting Measurements

- A test can be started or completed by the EXT.I/O, RS-232C, and switched probe in addition to the operation keys. A test can be started and completed by different methods.
- Check that the test leads are securely connected before starting a test.
- A test does not start when the EXT.I/O STOP signal is LOW.
- A test does not start when the interlock function is enabled.

4.2 During Measurement

The instrument applies test voltage to equipment to be measured during measurement.

1 When the test duration is set to [ON] (p.39)

- When the START key is pressed, test voltage is applied to the equipment to be measured, and the timer countdown starts. The remaining time is displayed in the test duration indicator (TIMER).
- During the response time, [D] is displayed on the left edge of the countdown time indicator, and the measured value indicator becomes blank (no display). The display during the response time is the same for both response time settings, [AUTO] and [MANUAL].
- After the response time has elapsed, the resistance measurement is performed for the time specified for the timer, and the measured value is displayed. (Unit: MΩ) When the comparator function is set, judgment is performed according to the test mode setting.

4

2 When the test duration is set to [OFF] (p.39)

- When the START key is pressed, test voltage is applied to the equipment to be measured, and the timer count-up starts. The time elapsed since the START key was pressed is displayed in the test duration indicator (TIMER).
- During the response time, [D] is displayed on the left edge of the count-up time indicator, and the measured value indicator becomes blank (no display). The display during the response time is the same for both response time settings, [AUTO] and [MANUAL].
- 3. After the response time has elapsed, the resistance measurement is performed until the **STOP** key is pressed, and the measured value is displayed. (Unit: $M\Omega$) The elapsed time is counted and displayed up to 999.9 s, but the resistance measurement is performed until the **STOP** key is pressed. When the comparator function is set, judgment is performed according to the test mode setting.

3 PASS/FAIL judgment display for the comparator function

Upper limit value ≤ Measured value	U.FAIL turns on.
Lower limit value < Measured value < Upper limit value	PASS turns on.
Measured value ≤ Lower limit value	L.FAIL turns on.

Refer to "3.7 Announcing the Judgment Results Using a Beep Sound" (p. 47) to set beep sound for PASS/FAIL judgment.

When the upper and lower limit values are not set, the indicator displays "----" and PASS/FAIL judgment is not performed. If either of the upper and lower limit values is set, PASS/FAIL judgment is performed according to the value. (p.44)

If the upper and lower limit values are set to values outside of the accuracy range, the U.FAIL and L.FAIL lamps turn on at the same time.

4 The timer indicator indicates the test duration countdown. When the test duration is not set, the indicator displays elapsed time.

4.3 Measured Value Display

A measured value outside of the accuracy range can also be displayed.

Measurement voltage	Display range
25 V ≤ V 100 V	0.000 M Ω to 400.0 M Ω
100 V ≤ V 500 V	$0.000~\text{M}\Omega$ to $4000~\text{M}\Omega$
500 V ≤ V ≤ 1000 V	$0.000~\text{M}\Omega$ to 9990 $\text{M}\Omega$

When the measure value is outside of the display range, "Over.F" or "Under.F" is displayed.

Refer to "9 Specifications" (p.147) for the accuracy range.

IMPORTANT

- The guaranteed accuracy range is different from the display range.
- When the resistance range is set to auto, it may take time to display a measured value immediately after a test starts due to range shift. To check a measured value immediately, set the resistance range to MANUAL. (Refer to "3.2 Setting the Range" (p. 36) for the setting procedure.)
- If PASS/FAIL judgment is obtained with a command in the auto range when the range is not set or before a measured value is displayed, ULFAIL (no judgment) is returned. Extend the test duration.
- In the auto range, the measured value may fluctuate between two resistance ranges. Set the resistance range to MANUAL.
- "Over.F" indicates overflow. "Over.F" is displayed when the measured value exceeds the display range maximum value in the auto range and when the measured value exceeds the maximum display value in each range in the MANUAL range.
- "Under.F" indicates underflow. "Under.F" is displayed when the measured value is 190 dgt. or less in the MANUAL range excluding 2 M Ω range. It is not displayed in the auto range.
- The more electrostatic capacitance components the equipment to be measured contains, the more the measured value fluctuates. Also it takes for an output voltage to rise.
- When the processing is performed at high speed (for example, the test duration is less than 100 ms), there is a possibility that the voltage monitor cannot be updated in time. To check the output voltage, monitor the waveform on an oscilloscope or other instruments using a high-pressure probe or other probes.

4.4 Completing Measurement

MARNING



To avoid electric shock, remove the measurement leads from an equipment to be measured after the TEST lamp is turned off after a test.

- 1 Tests are completed by one of the following.
 - The STOP key is pressed, the EXT.I/O STOP signal is LOW, or a test completion command is sent from the RS-232C.
 - · The set test duration elapses.
 - The test mode is set to FAIL STOP mode and FAIL judgment is made.
 - The test mode is set to PASS STOP mode and a PASS judgment is made.
 - The test mode is set to PASS STOP mode and PASS judgment is made.
 - The *RST, :STOP, :TIMER, or :DELay command is sent from the RS-232C.
- The measured value and COMP lamp displayed immediately before the test is completed continue to be displayed.
- 3 The TEST lamp may not turn off and continue to blink even after the test is completed. This indicates that any charge remaining in the equipment to be measured and instrument is being released. Follow "4.5 Automatic discharge function" to release any remaining charge.
- 4 After the TEST lamp turns off, remove the test leads.

4.5 Automatic Discharge Function

MARNING



When an insulation resistance test is performed on equipment to be measured that contains capacitance components, a test voltage equivalent load is charged which may result in electric shock.

A residual electric charge can be released through the internal circuit of the instrument.

After tests, follow the procedure below to release any remaining charge.

- Complete the test without removing the test leads from the equipment to be measured.
- The charge remaining in the equipment to be measured is automatically released in this instrument.
- 3 During discharge, the TEST lamp blinks.
- 4 When the voltage falls below approximately 10 V, the TEST lamp turns off.

5

Useful Functions

This chapter describes useful functions of the instrument.

"5.1 Checking Faulty Contact and Contact Status (Contact check function)"	p.56
"5.2 Checking Short Circuit before Applying the Set Voltage (Short circuit check function)"	p.60
"5.3 Enabling/Disabling the Key Operations"	p.65
"5.4 Setting the Key Operation Sound"	p.67
"5.5 Preventing Operation Errors at the Start of Testing (Double action function)"	p.68
"5.6 Adjusting the Screen Contrast"	p.69
"5.7 Adjusting the Backlight"	p.70
"5.8 Setting the Frequency of Power Supply Manually"	p.71
"5.9 Initializing the System (Reset)"	p.72
"5.10 Default Setting List"	p.73

Checking Faulty Contact and Contact Status (Contact check function)

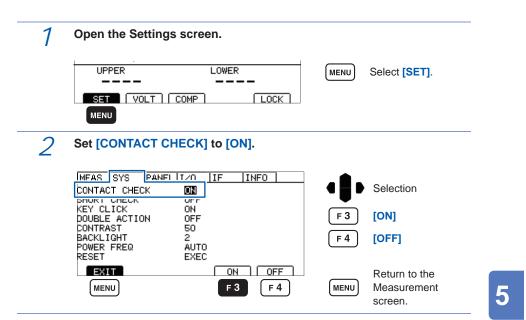
5.1 Checking Faulty Contact and Contact Status (Contact check function)

The faulty contact of the equipment to be measured and probes and the broken wires of the measurement cables are detected.

The measurement terminals on the rear panel of the instrument are used for contact check. The contact check function monitors the contacts from the start to the end of measurement in every sampling and can detect faulty contacts and broken wires of the probes not only before and after tests but also during the tests. If faulty contacts are detected, a contact error (ContLo $M\Omega$, ContHi $M\Omega$, or ContHL $M\Omega$) is displayed in the measured value display section, and the test stops. (The ERR signal is output from EXT.I/O.) When this error is displayed, check the probe contact and for any broken wires of the measurement cables. (The instrument needs to be repaired if the error does not disappear even when the measurement cables that are not broken are short circuited.)

IMPORTANT

- Even if the measurement speed is set to [FAST], the sampling time takes 100
 ms when the contact check function is ON. (The sampling time is 500 ms if the
 measurement speed is set to [SLOW] regardless of the function check setting.)
- When the contact check function is set to OFF, a measured value is displayed even if the probe is not in contact with the equipment to be measured.
- If the set test duration is shorter than the sampling time, a proper measurement cannot be performed. (The measured value may not be displayed.) Set a test duration that is longer than the sampling time.



Checking Faulty Contact and Contact Status (Contact check function)

Connecting test leads

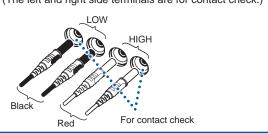
Rear panel



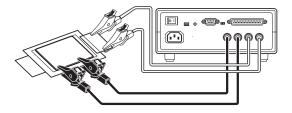
L2200 Connect the red plug to the HIGH terminal and the

black plug to the LOW terminal.

(The left and right side terminals are for contact check.)



Example of connection to equipment to be measured



IMPORTANT

Securely connect the test leads for the contact check to the equipment to be measured. When the test leads are not connected securely, a contact error occurs and no test can start. For the principles of the contact check function, refer to "Appx. 2 Contact Check Function" (p. Appx.2).

2-terminal contact check function

If the insulation resistance of the equipment to be measured is within the measurement range of the instrument, a 2-terminal contact check can be performed by setting the upper and lower limit values of the comparator.

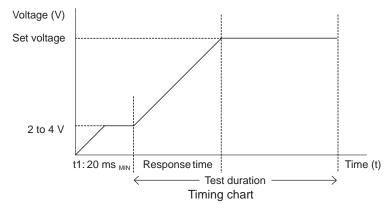
(Example) When the insulation resistance of the equipment to be measured is 100 M Ω

Test voltage	500 V
Upper limit value	110 MΩ
Lower limit value	90 MΩ
Test duration	1 s

- 1 Set the test voltage to 500 V.
- 2 Set the lower limit value to 90 MΩ and the upper limit value to 110 MΩ.
- 3 Set the test duration to 1 s.
- 4 Connect the HIGH and LOW side test leads to the equipment to be measured.
- 5 Start a test.
- 6 When the measured value is Over.F and the U.FAIL lamp turns on, the contact may be faulty or the probe wires may be broken.

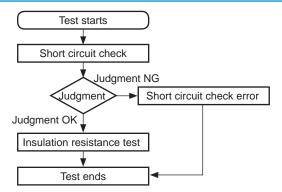
5.2 Checking Short Circuit before Applying the Set Voltage (Short circuit check function)

This is a function to check for short circuit by applying a low voltage (2 V to 4 V) to the equipment to be measured after starting a test and before applying the set voltage. If the equipment to be measured is short-circuited, a short circuit error (Short $M\Omega$) is displayed in the measured value display section, and the test stops. The set voltage is not applied. This function can prevent a judgment error when short circuit disappears when a high voltage is applied if the equipment to be measured is short-circuited by whiskers. The short circuit check function determines whether the equipment to be measured is short-circuited or not by applying direct current voltage and then measuring the current value. During the period immediately after the check is started, a difference cannot be identified between the short circuit of the insulator and the charging current to the electrostatic capacity. In this instrument, the current value is measured after the set time has elapsed to determine whether a short circuit occurs or not.



IMPORTANT

- If the equipment to be measured contains electrostatic capacitance components, t1 becomes longer. Set the time using the automatic measurement function for short circuit check time.
- The voltage to be applied fluctuates between 2 and 4 V depending on the equipment to be measured.



The time required for the automatic short circuit check is different between the correctly operating product and the short-circuited product. Each check takes up to $0.5 \, \text{s}$.

[AUTO] is also used for checking the shortest short circuit check execution time

How to check the shortest execution time

[AUTO]

When a correctly operating product is connected and a test is started, the short circuit check finishes as soon as the effect of the charging current has disappeared, and then the time taken is displayed.

Perform this process for multiple units of the equipment to be measured, and then set the longest time displayed (plus a little extra time) after **[MANUAL]** is selected.

The time taken for the short circuit check is displayed at the upper right of the measured value display section.

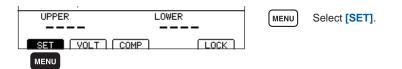
[MANUAL]

[MANUAL] is used to execute a short circuit check in the shortest time. The short circuit check time can be set freely in the range of 0.010 s to 1.000 s. (When the time required for a short circuit check is unknown, it is possible to determine an approximate time by setting [SHORT CHECK TIME] to [AUTO] and then performing the measurement several times. When [MANUAL] is selected, set the time in consideration of any variations in the characteristics of the measurement objects.)

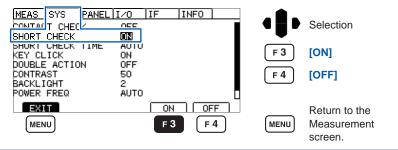
Checking Short Circuit before Applying the Set Voltage (Short circuit check function)

Setting to AUTO

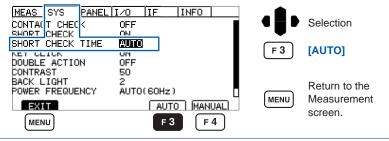
Open the Settings screen.



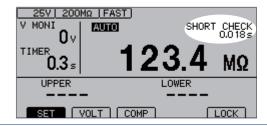
2 Set [SHORT CHECK] to [ON].
(When [ON] is selected, the [SHORT CHECK TIME] setting is displayed below.)



3 Set [SHORT CHECK TIME] to [AUTO].



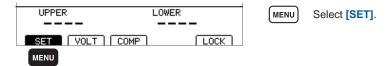
On completion of the short circuit check following starting the measurement, the short circuit check time is displayed.



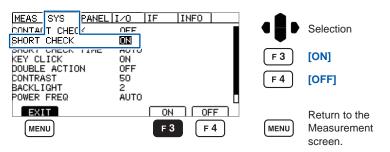
- The short circuit check function is operated using 100 k Ω as a criterion. Therefore, if equipment operating at 100 k Ω or less is measured, a short circuit check error occurs.
- When [SHORT CHECK TIME] is set to [AUTO] and the equipment to be measured is short-circuited, it takes 0.5 s for a short circuit check and "SHORT CHECK 0.500 s" is displayed.

Setting to MANUAL

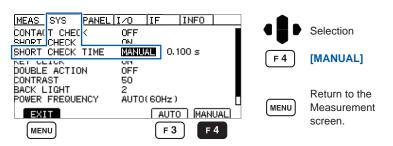
Open the Settings screen.

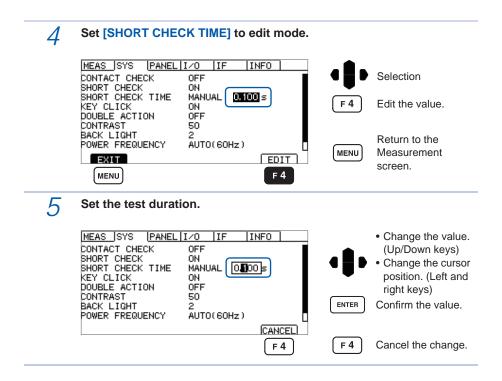


Set [SHORT CHECK] to [ON]. (When [ON] is selected, the [SHORT CHECK TIME] setting is displayed below.)



3 Set [SHORT CHECK TIME] to [MANUAL].



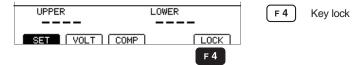


5.3 Enabling/Disabling the Key Operations

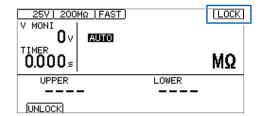
By executing the key lock function, the key operations other than **UNLOCK**, **START**, or **STOP** can be disabled.

Disabling the key operations (Key lock engaged)

1 Execute the key lock function.

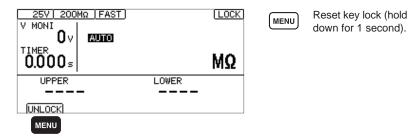


2 [LOCK] is displayed at the upper right corner and the key operations other than START or STOPare disabled.

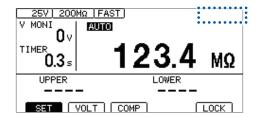


Enabling the key operations (Key lock cancelled)

1 Cancel the key lock function.

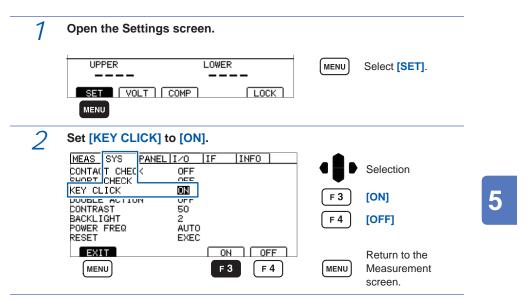


[LOCK] at the upper right corner disappears and the key operations are enabled.



5.4 Setting the Key Operation Sound

The key operation sound ON/OFF can be selected. In the default setting, the key sound is set to ON (beeps).

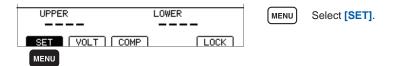


5.5 Preventing Operation Errors at the Start of Testing (Double action function)

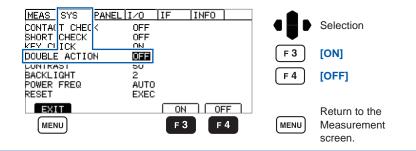
This is a function to prevent operation errors at the start of test and ensure safer test. No tests start unless the **START** key is pressed within 1 s after the **STOP** key is pressed when the double action function is set to ON. When the START is enabled, **DACTION** is displayed in the Measurement screen.

Operation errors can be prevented since the **STOP** key must be pressed before the **START** key is pressed.

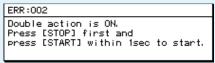




Set [DOUBLE ACTION] to [ON].



 When the double action function is set, the beeper sounds and the Error screen is displayed if the START key is pressed without pressing the STOP key.



• When the **START** is enabled, **DACTION** is displayed in the Measurement screen.

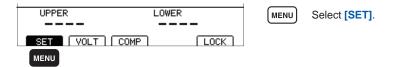


5.6 Adjusting the Screen Contrast

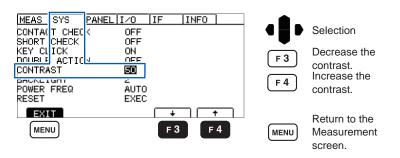
The screen contrast can be set between 0 and 100% in increments of 5%.

The screen may become difficult to see when ambient temperature changes.

Open the Settings screen.



Set the value for [CONTRAST].



5.7 Adjusting the Backlight

The backlight brightness can be adjusted to the illumination of the installation location.

The brightness can be set to 0 for communications. Be aware that the display may be difficult to see when the brightness is set to 0.

Open the Settings screen. UPPER LOWER Select [SET]. MENU SET VOLT COMP LOCK Set the value for [BACKLIGHT]. The smaller the value is, the lower the brightness becomes. MEAS SYS PANEL I/O | IF | INFO | CONTACT CHECK
SHORT CHECK
KEY CLICK
DOUBLE ACTICA Selection 0FF ON F 2 [1] ŌΝ BACKLIGHT 2 F 3 [2] POWER FREW RESET AUTU EXEC F 4 [3] EXIT MENU Return to the MENU Measurement

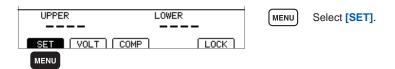
screen.

5.8 Setting the Frequency of Power Supply Manually

There are three power supply frequency settings: AUTO, 50 Hz, and 60 Hz. To eliminate any noise, the supply power frequency needs to be set properly. In the default setting, the power supply frequency is supposed to be identified automatically (AUTO) when the power is supplied, however, it also can be set manually.

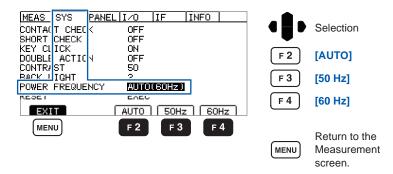
If the power supply frequency is not set properly, a measured value does not stabilize. Even in the AUTO setting, if the power supply frequency cannot be detected properly due to significant power noise, an error (ERR:097) is displayed when the power is supplied. Set the frequency according to the power supply.

Open the Settings screen.



Set [POWER FREQ].

(When [AUTO] is set, the automatically identified power frequency is displayed on the right.)



The power frequency is identified automatically only once when the power is supplied.

After the power supply frequency setting is changed from [50Hz] or [60Hz] to [AUTO], turn off the power supply and then turn it on again.

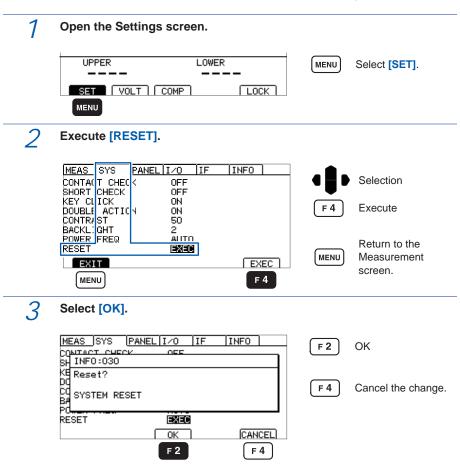
5

5.9 Initializing the System (Reset)

All measurement conditions and panel data are reset to the default settings. There are three ways to reset.

- · Reset in the System Settings screen.
- With the power off, turn on the power while pressing (MENU) and (Up cursor key) at the same time.
- · Reset with the communication command.
- *RST command (The interface setting is not initialized.)

This section describes the procedure to reset in the System Settings screen.



5.10 Default Setting List

Screen		Setting and key	Default setting	Reference
		COMP UPPER	OFF	p.44
		COMP LOWER	OFF	p.44
		LOCK	OFF	p.65
Settings	Measurement	VOLTAGE	25 V	p.34
screen (SET)	Settings screen	RANGE	AUTO	p.36
	(MEAS)	SPEED	FAST	p.38
		TIMER	OFF	p.39
		DELAY	AUTO	p.39
		COMP MODE	CONTINUE	p.46
		COMP BEEP	FAIL	p.47
	System screen	CONTACT CHECK	OFF	p.56
	(SYS)	SHORT CHECK	OFF	p.60
		KEY CLICK	ON	p.67
		DOUBLE ACTION	OFF	p.68
		CONTRAST	50	p.69
		BACKLIGHT	2	p.70
		POWER FREQ	AUTO	p.71
		RESET	EXEC	p.72
	Memory function	1 to 10	None	p.75
	EXT.I/O Settings	ANALOG OUT RANGE	FULL	p.104
	screen (I/O)	EXT.SWITCH MODE	CONT	p.108
		EXT.I/O TEST-PIN	SLOW	p.101
		INTERLOCK	OFF	p.106
		EXT.I/O TEST	EXEC	p.103
	Communications	RS-232C SPEED	9600 bps	p.114
	Interface Settings	DATA OUT	OFF	p.117
	screen (IF)	CMD MONITOR	OFF	p.120

Saving and Loading Measurement Conditions (Memory function)

Panel save function

The current measurement conditions can be saved.

Up to 10 patterns of measurement conditions can be saved and retained even when the power is turned off.

Settings that can be saved with the panel save function

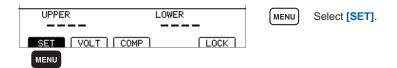
- Test voltage
- Range (including auto range ON/OFF and resistance range for the fixed range)
- Test speed
- Test duration
- Response time
- Comparator upper and lower limit values (including comparator ON/OFF)
- Test mode
- Judgment beep sound

Panel load function

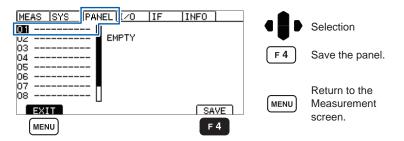
The measurement conditions saved by the panel save function are loaded. The measurement conditions can be loaded by the operation key, RS-232C command, or EXT.I/O.

6.1 Saving the Measurement Conditions (Panel save function)

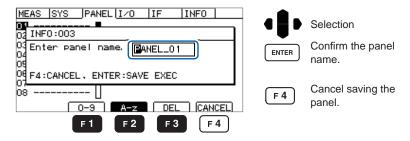
Open the Settings screen.



Select the panel number to be saved. The panel description is displayed on the right side of the screen.



3 Enter and confirm the panel name.



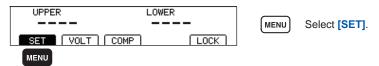
Key operations for entering a panel name

Key	Operation
•⊕•	Moves the cursor.
a b	Changes the characters and values.
F1	Enters a number from 0 to 9.
F2	Enters a letter from A to Z or an underscore character (_).
F3	Deletes a character.

6.2 Loading the Measurement Conditions (Panel load function)

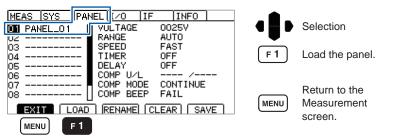
The measurement conditions saved by the panel save function are loaded.

Open the Settings screen.

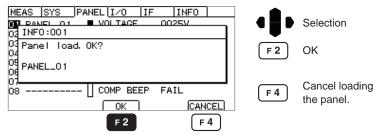


Select and load the panel number.

The panel description is displayed on the right side of the screen.



Select [OK] in the confirmation screen.



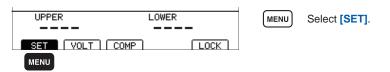
The panel name is displayed in the Measurement screen.



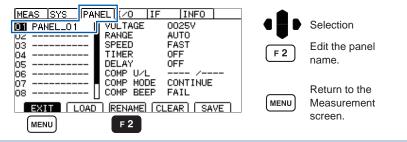
Measurement conditions can be loaded with the EXT.I/O control by using LOAD0 to LOAD3 or the communications commands. Refer to p. 123 for details on commands. When the measurement conditions are changed after loading, the panel name is no longer displayed.

6.3 Changing the Panel Name

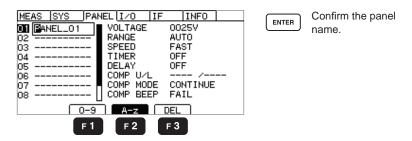
7 Open the Settings screen.



2 Select the panel number and select [RENAME].



3 Change and confirm the panel name.



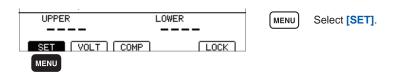
Key operations for entering a panel name

Key	Operation
•⊕•	Moves the cursor.
a b	Changes the characters and values.
F1	Enters a number from 0 to 9.
F2	Enters a letter from A to Z or an underscore character (_).
F 3	Deletes a character.

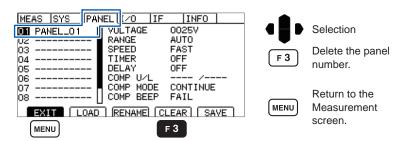
Deleting the Panel Data

The measurement conditions saved by the panel save function are deleted.

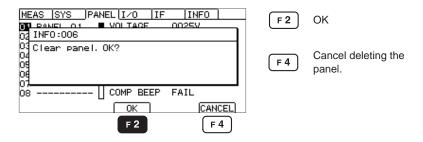
Open the Settings screen.



Select and delete the panel number. The panel description is displayed on the right side of the screen.



3 Select [OK] in the confirmation screen.

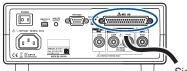


The panel data cannot be restored once it is deleted.

External Control (EXT.I/O)

The EXT.I/O terminal on the rear panel of the instrument supports external control by providing output of the TEST and comparator judgment signals, and accepting input of the START and STOP signals.

All signals are isolated with photocouplers. (The input/output common terminals are shared.) The input circuit can be switched to accommodate either current sink output (NPN) or current source output (PNP) by the internal settings of the instrument. Check the input/output ratings and internal circuit structure, understand the safety precautions for connecting a control system, and use accordingly.



Signal output or input

Check the controller input and output specifications.



Set the EXT.I/O mode switch (NPN/PNP) on the instrument. (Operate the switch after the instrument power is turned off.)



Connect the EXT.I/O terminal to the signal output and input.



Set the instrument.

7.1 External Input/Output Terminal and Signals

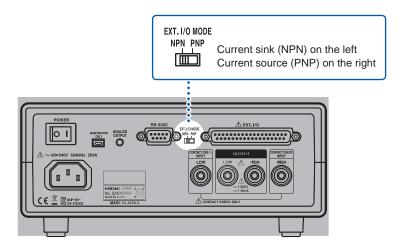
Switching between current sink (NPN) and current source (PNP)

Before switching, thoroughly read "Before switching between current sink (NPN) and current source (PNP)" (p. 11).

The EXT.I/O mode switch (NPN/PNP) allows you to change the type of PLC (programmable controller) that is supported.

The instrument ships with the switch set to the NPN position.

	EXT.I/O mode switch (NPN/PNP) setting NPN PNP			
Input circuit	Supports sink output.	Supports source output.		
Output circuit	Non-polar	Non-polar		
ISO_5 V output	+5 V output	-5 V output		



A CAUTION



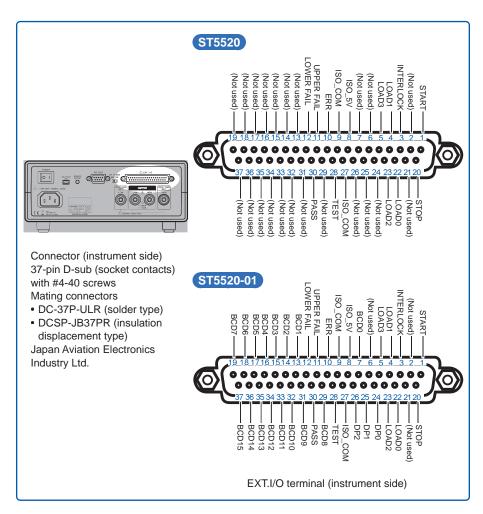
Do not operate the EXT.I/O mode switch (NPN/PNP) while the instrument is on.

Before connecting a connector, thoroughly read "Before connecting EXT.I/O" (p.12).

Use of EXT.I/O enables the following control functionality:

- Measurement start (START) → Measurement end (rising TEST signal) →
 Acquisition of judgment results (UPPER_FAIL, LOWER_FAIL, PASS and various
 ERR)
- Panel load (LOAD0 to LOAD3)

The functionality described in "Performing an I/O test (EXT.I/O test function)" (p. 103) provides a convenient way to check the EXT.I/O operation.



7

ST5520

Pin	Signal name	I/O	Function	Logic	Pin	Signal name	I/O	Function	Logic
1	START	IN	Measurement start	Edge	20	STOP	IN	Measurement end	Edge
2	(Not used)	-	-	-	21	(Not used)	-	-	-
3	INTERLOCK	IN	Interlock	Level	22	LOAD0	IN	Panel number selection	Level
4	LOAD1	IN	Panel number selection	Level	23	LOAD2	IN	Panel number selection	Level
5	LOAD3	IN	Panel number selection	Level	24	(Not used)	-	-	-
6	(Not used)	-	-	-	25	(Not used)	-	-	-
7	(Not used)	-	-	-	26	(Not used)	-	-	-
8	ISO_5V	-	Isolated power supply +5 V (-5 V) output	-	27	ISO_COM	-	Isolated common signal ground	-
9	ISO_COM	-	Isolated common signal ground	-	28	TEST	OUT	During measurement	Level
10	ERR	OUT	Contact check error Short circuit check error Output voltage error	Level	29	(Not used)	-	-	-
11	UPPER FAIL	OUT	Comparator judgment	Level	30	PASS	OUT	Comparator judgment	Level
12	LOWER FAIL	OUT	Comparator judgment	Level	31	(Not used)	-	-	-
13	(Not used)	-	-	-	32	(Not used)	-	-	-
14	(Not used)	-	-	-	33	(Not used)	-	-	-
15	(Not used)	-	-	-	34	(Not used)	-	-	-
16	(Not used)	-	-	-	35	(Not used)	-	-	-
17	(Not used)	-	-	-	36	(Not used)	-	-	-
18	(Not used)	-	-	-	37	(Not used)	-	-	-
19	(Not used)	-	-	- 1					

- The connector frame is connected to the metal part on the instrument rear panel as well as the power inlet protective ground terminal.
- When switching panel load operation using commands or key operation, fix pins 4 and 5 as well as 22 and 23 to ON or OFF. (p.87)
- Output timing of the TEST signal varies depending on the setting of the TEST signal OFF timing.

Refer to "7.4 Setting the TEST Signal OFF Timing" (p. 101).

ST5520-01

Pin	Signal name	I/O	Function	Logic	Pin	Signal name	I/O	Function	Logic
1	START	IN	Measurement start	Edge	20	STOP	IN	Measurement end	Edge
2	(Not used)	-	-	-	21	(Not used)	-	-	-
3	INTERLOCK	IN	Interlock	Level	22	LOAD0	IN	Panel number selection	Level
4	LOAD1	IN	Panel number selection	Level	23	LOAD2	IN	Panel number selection	Level
5	LOAD3	IN	Panel number selection	Level	24	DP0	OUT	Decimal point output	Level
6	(Not used)	-	-	-	25	DP1	OUT	Decimal point output	Level
7	BCD0	OUT	BCD	Level	26	DP2	OUT	Decimal point output	Level
8	ISO_5V	-	Isolated power supply +5 V (-5 V) output	-	27	ISO_COM	-	Isolated common signal ground	-
9	ISO_COM	-	Isolated common signal ground	-	28	TEST	OUT	During measurement	Level
10	ERR	OUT	Contact check error Short circuit check error Output voltage error	Level	29	BCD8	OUT	BCD	Level
11	UPPER FAIL	OUT	Comparator judgment	Level	30	PASS	OUT	Comparator judgment	Level
12	LOWER FAIL	OUT	Comparator judgment	Level	31	BCD9	OUT	BCD	Level
13	BCD1	OUT	BCD	Level	32	BCD10	OUT	BCD	Level
14	BCD2	OUT	BCD	Level	33	BCD11	OUT	BCD	Level
15	BCD3	OUT	BCD	Level	34	BCD12	OUT	BCD	Level
16	BCD4	OUT	BCD	Level	35	BCD13	OUT	BCD	Level
17	BCD5	OUT	BCD	Level	36	BCD14	OUT	BCD	Level
18	BCD6	OUT	BCD	Level	37	BCD15	OUT	BCD	Level
19	BCD7	OUT	BCD	Level					

- The connector frame is connected to the metal part on the instrument rear panel as well as the power inlet protective ground terminal.
- When switching panel load operation using commands or key operation, fix pins 4 and 5 as well as 22 and 23 to ON or OFF. (p.87)
- Output timing of the TEST signal varies depending on the setting of the TEST signal OFF timing.

Refer to "7.4 Setting the TEST Signal OFF Timing" (p. 101).

Signal descriptions

1 Isolated power supply

Pin	Signal name	EXT.I/O mode switch (NPN/PNP) setting		
FIII	Signal name	NPN	PNP	
8	ISO_5V	Isolated power supply +5 V	Isolated power supply -5 V	
9, 27	ISO_COM	Isolated common signal ground		

2 Input signals

START	The START signal starts a test and generates output voltage.		
STOP	The STOP signal ends a test and shuts off output voltage.		
INTERLOCK	The signal to switch the interlock function between ON and OFF (When the interlock function is set to be enabled) Open the signal to switch to ON; or short-circuit, OFF. When the interlock function is ON, no tests can be started. In addition, if the interlock function is changed to ON during a test, the test stops. Refer to "7.7 Interlock Function" (p. 106) to set the interlock function.		
LOAD0 to LOAD3	Saved test conditions can be selected. While a LOAD signal is input, the instrument enters the key lock state, accepting no key operations.		

3 Output signals

PASS	This signal is output when the comparator judgment is PASS.
UPPER FAIL	This signal is output when the comparator judgment is UPPER FAIL.
LOWER FAIL	This signal is output when the comparator judgment is LOWER FAIL.
TEST	This signal is output during tests (During discharge, it is output based on the setting of TEST signal OFF timing).
ERR	This signal is output at the time of a contact check error, short circuit check error, output voltage error judgment. It is output when the contact check function or the short circuit check function is set to ON.
DP0 to DP2	The decimal point position is output in 4 bits when BCD output is used. (ST5520-01 only)
BCD0 to BCD15	A 4-digit and 16-bit measured value is output. (ST5520-01 only)

 $\ensuremath{\mathsf{EXT.I/O}}$ input and output signals cannot be used while measurement conditions are changed.

4 Signal correspondence chart

LOAD0 to LOAD3

LOAD3	LOAD2	LOAD1	LOAD0	Panel number
OFF	OFF	OFF	OFF	No change
OFF	OFF	OFF	ON	1
OFF	OFF	ON	OFF	2
OFF	OFF	ON	ON	3
OFF	ON	OFF	OFF	4
OFF	ON	OFF	ON	5
OFF	ON	ON	OFF	6
OFF	ON	ON	ON	7
ON	OFF	OFF	OFF	8
ON	OFF	OFF	ON	9
ON	OFF	ON	OFF	10

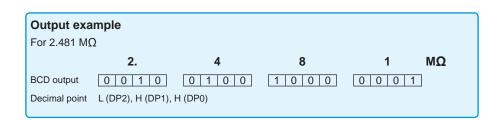
Decimal point output

DP2	DP1	DP0	Decimal point output
Н	Н	Н	2000
Н	Н	L	200.0
Н	L	Н	20.00
L	Н	Н	2.000

7

BCD output





Timing Chart

7.2 Timing Chart

The each signal level indicates the ON/OFF status of a contact. In the current source (PNP) setting, the signal level is the same as the voltage level of EXT.I/O terminal. In the current sink (NPN) setting, the High and Low voltage levels are reversed.

Set the signal before starting a test to control the measurement conditions at the EXT.I/O terminal (LOAD0 to LOAD3). The measurement conditions cannot be changed during tests.

IMPORTANT

When the START signal is input after the test voltage is changed, a time of up to 500 ms is added to detect the START signal.

Example

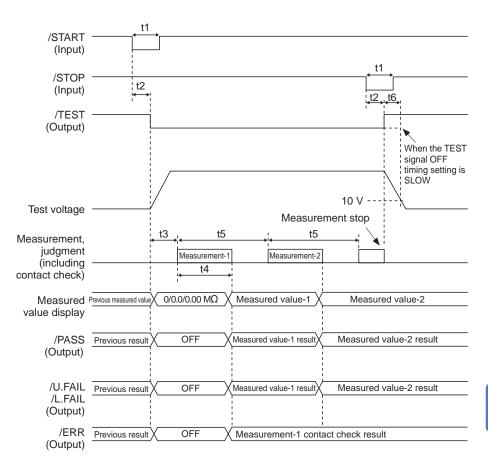
When the test voltage is changed by using the LOAD signal When the test voltage is changed by using the RS command

Continuous test mode timing chart (1)

When the test duration setting (TIMER) is OFF and the measurement is performed by the /START signal or /STOP signal input from EXT.I/O or when the test duration setting (TIMER) is OFF and the measurement is performed by the START key or STOP key on the panel

Setting

Test duration (TIMER) Response time (DELAY)		TEST signal OFF timing
OFF	AUTO, 5 ms to 999.9 s	FAST



	Item		Time
t1	START, STOP signal pulse width		5 ms _{MIN.}
t2	START, STOP signal detection time		5 ms _{MAX.} *
t3	Response time (DELAY)		AUTO, 5 ms to 999.9 s
t4	Measurement time	Contact check: OFF	30 ms (FAST), 480 ms (SLOW)
		Contact check: ON	80 ms (FAST), 480 ms (SLOW)
t5	Measurement	Contact check: OFF	50 ms (FAST), 500 ms (SLOW)
	interval	Contact check: ON	100 ms (FAST), 500 ms (SLOW)
t6	Discharge time (time for the output voltage to drop below 10 V)		20 ms _{MAX.} (during pure resistance measurement)

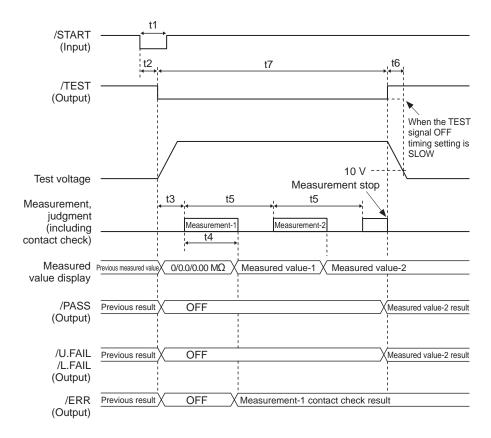
^{*} When the START signal is input after the test voltage is changed, a time of up to 500 ms is added to detect the START signal.

Continuous test mode timing chart (2)

When the test duration setting (TIMER) is ON and the measurement is performed by the /START signal input from EXT.I/O or when the test duration setting (TIMER) is ON and the measurement is performed by the START key on the panel

Setting

Test duration (TIMER)	Response time (DELAY)	TEST signal OFF timing
ON, 45 ms to 999.9 s	AUTO, 5 ms to 999.9 s	FAST



	Item		Time
t1	START, STOP	signal pulse width	5 ms _{MIN.}
t2	START, STOP	signal detection time	5 ms _{MAX.} *
t3	Response time (DELAY)		AUTO, 5 ms to 999.9 s
t4	Measurement	Contact check: OFF	30 ms (FAST), 480 ms (SLOW)
	time	Contact check: ON	80 ms (FAST), 480 ms (SLOW)
t5	Measurement	Contact check: OFF	50 ms (FAST), 500 ms (SLOW)
	interval	Contact check: ON	100 ms (FAST), 500 ms (SLOW)
t6	Discharge time (time for the output voltage to drop below 10 V)		20 ms _{MAX.} (during pure resistance measurement)
t7	Test duration (TIMER)		45 ms to 999.9 s

^{*} When the START signal is input after the test voltage is changed, a time of up to 500 ms is added to detect the START signal.

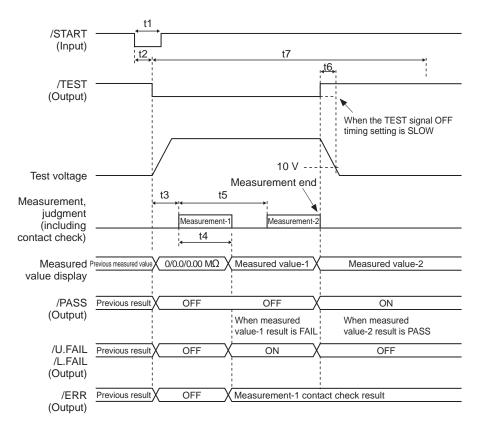
PASS STOP mode timing chart

When the test duration setting (TIMER) is ON and the measurement is performed by the /START signal input from EXT.I/O or when the test duration setting (TIMER) is ON and the measurement is performed by the START key on the panel

Setting

Test duration (TIMER)	Response time (DELAY)	TEST signal OFF timing
ON, 45 ms to 999.9 s	AUTO, 5 ms to 999.9 s	FAST

When the test duration (TIMER) is set to OFF, tests are performed continuously until a PASS judgment is made.



	Item		Time
t1	START, STOP	signal pulse width	5 ms _{MIN.}
t2	START, STOP	signal detection time	5 ms _{MAX.} *
t3	Response time	(DELAY)	AUTO, 5 ms to 999.9 s
t4 Measurement	Measurement	Contact check: OFF	30 ms (FAST), 480 ms (SLOW)
	time	Contact check: ON	80 ms (FAST), 480 ms (SLOW)
t5	Measurement	Contact check: OFF	50 ms (FAST), 500 ms (SLOW)
	interval	Contact check: ON	100 ms (FAST), 500 ms (SLOW)
t6	Discharge time (time for the output voltage to drop below 10 V)		20 ms _{MAX.} (during pure resistance measurement)
t7	Test duration (TIMER)		45 ms to 999.9 s

^{*} When the START signal is input after the test voltage is changed, a time of up to 500 ms is added to detect the START signal.

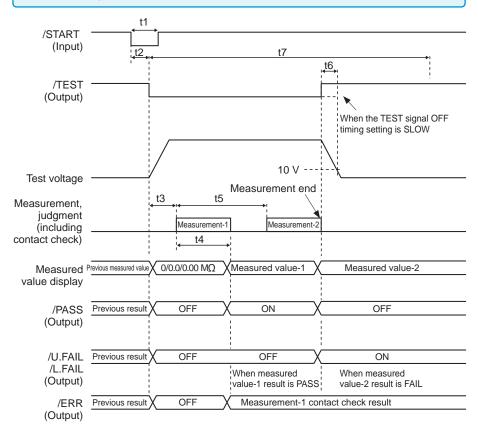
FAIL STOP mode timing chart

When the test duration setting (TIMER) is ON and the measurement is performed by the /START signal input from EXT.I/O or when the test duration setting (TIMER) is ON and the measurement is performed by the START key on the panel

Setting

Test duration (TIMER)	Response time (DELAY)	TEST signal OFF timing
ON, 45 ms to 999.9 s	AUTO, 5 ms to 999.9 s	FAST

When the test duration (TIMER) is set to OFF, tests are performed continuously until a FAIL judgment is made.



Timing Chart

	Item		Time
t1	START, STOP signal pulse width		5 ms _{MIN.}
t2	START, STOP	signal detection time	5 ms _{MAX.} *
t3	Response time (DELAY)		AUTO, 5 ms to 999.9 s
t4	t4 Measurement time	Contact check: OFF	30 ms (FAST), 480 ms (SLOW)
		Contact check: ON	80 ms (FAST), 480 ms (SLOW)
t5	Measurement	Contact check: OFF	50 ms (FAST), 500 ms (SLOW)
	interval	Contact check: ON	100 ms (FAST), 500 ms (SLOW)
t6	Discharge time (time for the output voltage to drop below 10 V)		20 ms _{MAX.} (during pure resistance measurement)
t7	Test duration (TIMER)		45 ms to 999.9 s

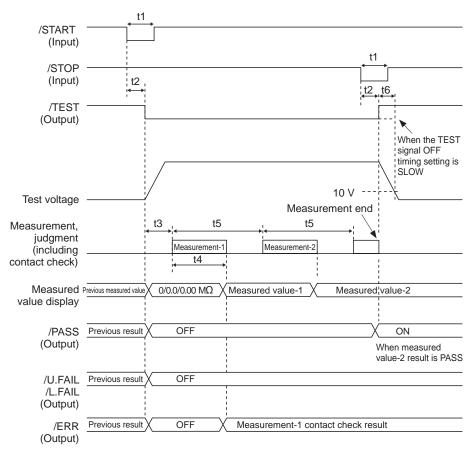
^{*} When the START signal is input after the test voltage is changed, a time of up to 500 ms is added to detect the START signal.

Forced termination judgment mode timing chart

When the test duration setting (TIMER) is OFF and the measurement is performed by the /START signal or /STOP signal input from EXT.I/O or when the test duration setting (TIMER) is OFF and the measurement is performed by the START key or STOP key on the panel

Setting

Test duration (TIMER)	Response time (DELAY)	TEST signal OFF timing
OFF	AUTO, 5 ms to 999.9 s	FAST

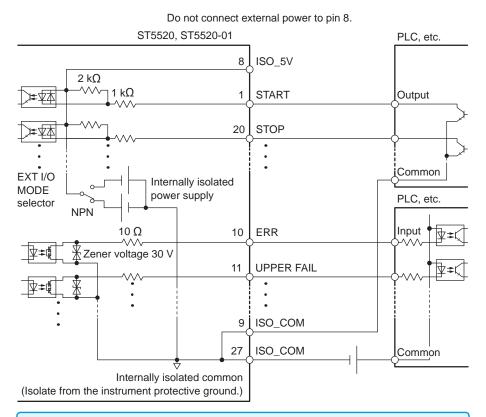


		Item	Time
t1	START, STOP	signal pulse width	5 ms _{MIN.}
t2	START, STOP	signal detection time	5 ms _{MAX.} *
t3	Response time (DELAY)		AUTO, 5 ms to 999.9 s
t4	Measurement time	Contact check: OFF	30 ms (FAST), 480 ms (SLOW)
		Contact check: ON	80 ms (FAST), 480 ms (SLOW)
t5	Measurement	Contact check: OFF	50 ms (FAST), 500 ms (SLOW)
	interval	Contact check: ON	100 ms (FAST), 500 ms (SLOW)
t6	Discharge time (time for the output voltage to drop below 10 V)		20 ms _{MAX.} (during pure resistance measurement)

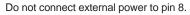
^{*} When the START signal is input after the test voltage is changed, a time of up to 500 ms is added to detect the START signal.

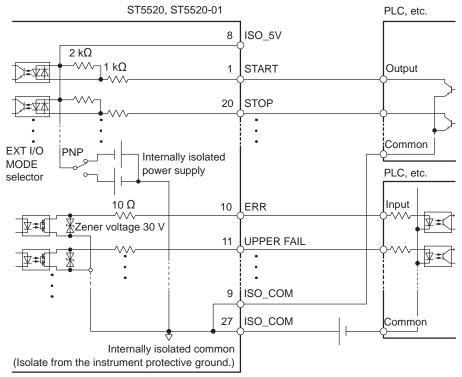
7.3 Internal Circuit Configuration

NPN setting



- Use ISO_COM as the common terminal for both input and output signals.
- If a high current flows to common wiring, branch the output signal common wiring and input signal common wiring from the position close to the ISO_COM terminal.





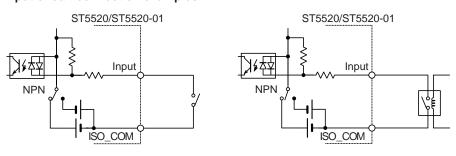
Use ISO_COM as the common terminal for both input and output signals.

Electrical specifications

Input signals	Input type	Photocoupler-isolated, non-voltage contact inputs (Current sink/source output compatible)	
	Input ON	Residual voltage 1 V or less (Input ON current 4 mA (reference value))	
	Input OFF	OPEN (Shutoff current 100 μA or less)	
Output signals	Output type	Photocoupler-isolated, open drain output (non-polar)	
	Maximum load voltage	30 V DC _{MAX}	
	Maximum output current	50 mA/ch	
	Residual voltage	1 V or less (load current 50 mA)/0.5 V or less (load current 10 mA)	
Internally isolated power supply		e Sink output: 5.0 V±10%, source output: -5.0 V±10%	
	Maximum output current	100 mA	
	External power input	None	
	Isolation	Floating from protective ground potential and measurement circuit	
	Isolation rating	Terminal to ground voltage $$ 50 V DC, 33 V AC $_{\text{RMS}},$ and 46.7 V $_{\text{PEAK}}$ AC or less	

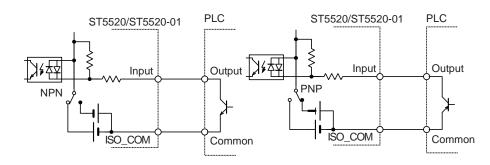
Connection examples

Input circuit connection examples



Switch connections

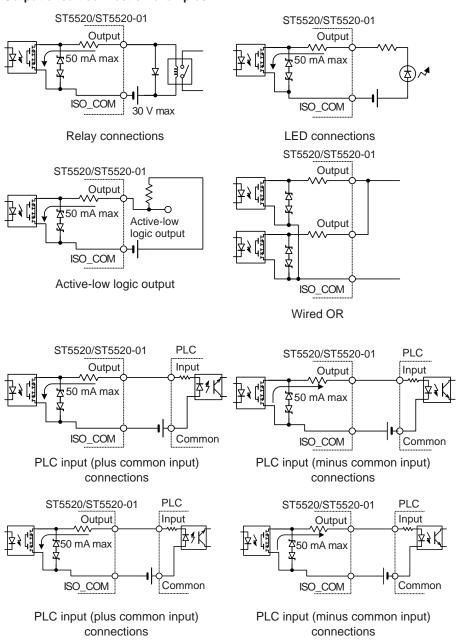
Relay connections



PLC output (NPN output) connections

PLC output (PNP output) connections

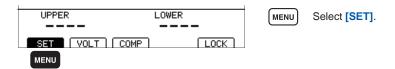
Output circuit connection examples



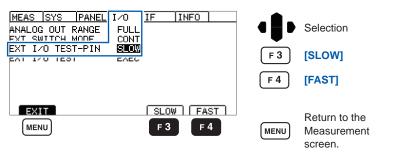
7.4 Setting the TEST Signal OFF Timing

There are two timing options for the EXT.I/O TEST signal output to return from LOW to HIGH when a test is completed.

1 Open the Settings screen.



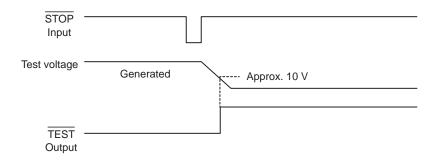
Select the operation mode for [EXT.I/O TEST-PIN].



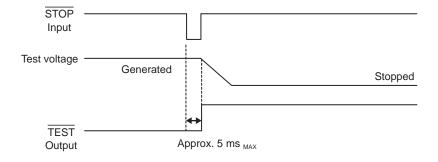
[SLOW]	After a test is completed, LOW (status during the test) is maintained until the voltage of the equipment to be measured drops to approximately 10 V due to the discharge function.
[FAST]	Regardless of the level of discharge, the status returns to HIGH almost simultaneously after a test is completed.

7

SLOW



FAST

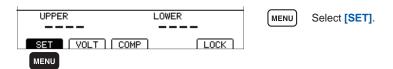


7.5 Checking External Control

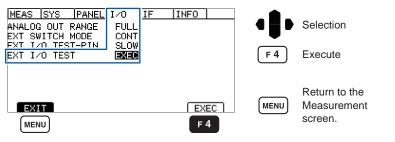
Performing an I/O test (EXT.I/O test function)

In addition to switching output signals between ON and OFF manually, the input signal status can be viewed on the screen.

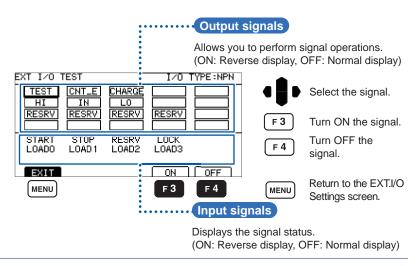
Open the Settings screen.



Select the operation mode for [EXT.I/O TEST].



? Perform the EXT.I/O test.



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7.6 Using Analog Output

There are two voltage output ranges of analog output.

During a test, analog output is output at the same timing as the measured value display. After the test is completed, analog output continues to output and hold the final voltage.

7 0 to 4 V is output within the all measured resistance ranges. ([FULL]) Regardless of the resistance range, AUTO or HOLD, the voltage is output as shown below

When 0.000 $M\Omega$ is displayed, 0 V is output. When the maximum value in the measurement range for each test voltage is displayed, 4 V is output. The voltage proportional to the resistance is output in the middle.

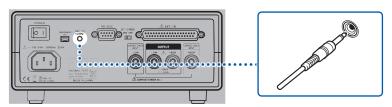
Measurement voltage	Displayed resistance	Output voltage (DC)
25 V ≤ V < 100 V	0.000 M Ω to 200.0 M Ω	0 V to 4 V
100 V ≤ V < 500 V	0.000 M Ω to 2000 M Ω	0 V to 4 V
500 V ≤ V ≤ 1000 V	0.000 M Ω to 4000 M Ω	0 V to 4 V
All magazirament valtages	Over. F	4 V
All measurement voltages	Under. F	0 V

The voltage is output according to each resistance range. ([EACH]) When the resistance range is set to [HOLD], the voltage is output as shown below. When the maximum value in each resistance range is displayed, 4 V is output. When the resistance range is set to [AUTO], the voltage is output as shown in Table 1. For the procedure to set and check the resistance range, refer to "3.2 Setting the Range" (p.36).

Resistance range	Displayed resistance	Output voltage (DC)
2 ΜΩ	$0.000~\text{M}\Omega$ to $2.000~\text{M}\Omega$	0 V to 4 V
20 ΜΩ	1.90 M Ω to 20.00 M Ω	0.38 V to 4 V
200 ΜΩ	19.0 MΩ to 200.0 MΩ	0.38 V to 4 V
2000 MΩ (100 V ≤ V < 500 V)	190 MΩ to 2000 MΩ	0.38 V to 4 V
4000 MΩ (500 V ≤ V ≤ 1000 V)	190 MΩ to 4000 MΩ	0.19 V to 4 V
All resistance ranges	Over. F	4 V
	Under. F	0 V

"Under. F" is displayed and 0 V is output when the measured value is less than 1.90 $M\Omega$ in 20 $M\Omega$ range, less than 19.0 $M\Omega$ in 2000/4000 $M\Omega$ range.

Connecting the output cord



The analog output terminal on the rear panel outputs direct voltage proportional to the resistance.

When connecting to a recorder, etc., use an output cord with an input resistance of 1 $\mbox{M}\Omega$ or more.

When the input resistance is low, accurate measurement cannot be performed.

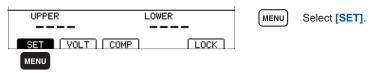
ACAUTION



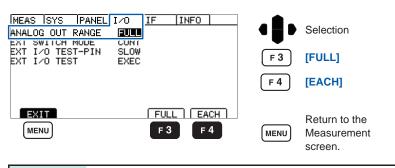
To avoid damage to the instrument or the output cord, do not input voltage or current externally to the analog output terminal. Do not connect the output cord plug to the measurement terminal of the instrument.

Setting the analog output

1 Open the Settings screen.



Select [ANALOG OUT RANGE].



[FULL] 0 to 4 V is output within the all measured resistance ranges.

The voltage is output according to each resistance range.

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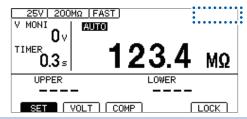
7.7 Interlock Function

The interlock function is used to cut off any output from the instrument by linking with an external device.

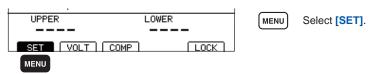
Once the interlock function is activated, all key operations are disabled. When the interlock function is enabled in the I/O screen of the EXT.I/O Settings screen, the interlock function runs when Pin 3 of EXT.I/O (INTERLOCK) is ON.

- Connect pin 3 of EXT.I/O (INTERLOCK) to ISO_COM (pin 9, pin 27). (p.83)
- Check that [LOCK] at the upper right corner is not lit on the Measurement screen.

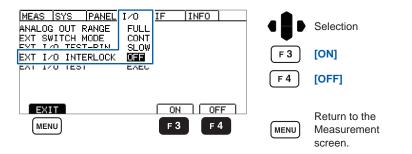
If **[LOCK]** is lit, there is a possibility of a connection failure. Check the connection performed in step 1.



3 Open the Settings screen.



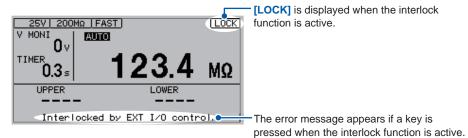
Make the settings for INTERLOCK.



[ON]	The interlock function is activated. All key operations are disabled. In addition, no tests can be started using EXT.I/O, any command, or a switched probe. If the interlock function is changed to ON during the test, the test is stopped.
[OFF]	The interlock function is not set. (Default setting) Normal tests can be performed.

If a key is pressed when the interlock function is active

When the interlock function is active, **[LOCK]** is displayed at the upper right corner of the screen. If a key is pressed in this status, an error message appears.



When the interlock function is enabled and INTERLOCK of EXT.I/O is open, once the interlock function is turned to ON, the interlock cannot be canceled from the Settings screen.

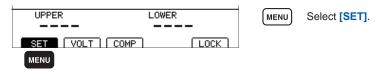
Refer to "10.2 Troubleshooting" (p. 163).

7.8 Using the Switched Probe

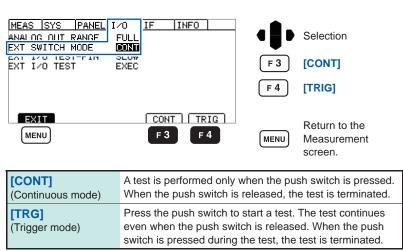
The optional switched probe enables the start and stop operations of the ST5520/ST5520-01 while the probe is held in hand.

Before a test, set the push switch mode to either trigger ([TRIG]) or continuous ([CONT]). It is initially set to continuous mode ([CONT]).

Open the Settings screen.



Select the operation mode for [EXT.SWITCH MODE].



- For the operation of the ST5520 and ST5520-01 when the switched probe is used, refer to "Enabled/disabled input list" (p.159).
- The 9299 Switched Probe can be used as an ordinary probe when the switch signal line plug is not connected to the EXT.SW terminal.

∴ WARNING

· When the switch signal line plug is inserted into the terminal, the TEST lamp may blink and high voltage may occur in the measurement terminal or the probe tip. To avoid the risk of electric shock, make sure to remove the measurement probe from the measurement terminal before connecting the switch signal line plug to the instrument.



· Do not press the push switch on the switched probe when connecting and disconnecting the switched probe. Unintentional high voltage may be generated which may cause electric shock or damage to the connected equipment.

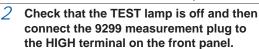
IMPORTANT

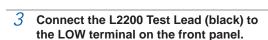
When the switched probe is used, one more measurement probe is required. Prepare the extra L2200 (black).

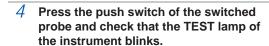
Connecting the Switched Probe

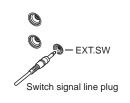
Connect the 9299 switch signal line plug to the EXT.SW terminal on the front of the instrument. (Insert the plug completely until the metal part of the signal line plug is not exposed.)

When the TEST lamp blinks, press the push switch of the 9299 or the STOP key of the ST5520/ ST5520-01 to turn off the TEST lamp.















Using the Switched Probe

Disconnecting the switched probe

IMPORTANT

When disconnecting the switched probe from the instrument, remove the switch signal line plug last.



7.9 Accessory Connector Assembly

The EXT.I/O connector and covers, etc. are supplied with the instrument. Assemble the connector according to the following procedure.

- Use a shielded cable to connect the EXT.I/O connector and a PLC, etc. If a shielded cable is not used, the influence of noise could cause the system to malfunction.
- Connect the shield to the ISO_COM terminal of EXT.I/O.
- If any of the supplied screws are missing or damaged, contact your authorized Hioki distributor or reseller.

Required items

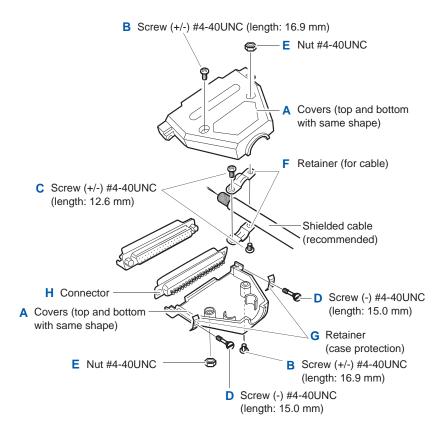
- Screwdriver
- · Shielded cable
- · Soldering iron

Accessories

• A Cover 1 set (2 pieces) • B Screw (+/-) #4-40UNC (length: 16.9 mm) 2 pieces • C Screw (+/-) #4-40UNC (length: 12.6 mm) 2 pieces • D Screw (-) #4-40UNC (length: 15.0 mm) 2 pieces • E Nut #4-40UNC 2 pieces • F Retainer (for cable) 2 pieces • G Retainer (case protection) 2 pieces • H Connector 1 piece

Assembly procedure

- 1. Solder the cable (shielded cable) to connector (H) of EXT.I/O.
- 2. Attach retainers (F) to the cable using screws (C).
- 3. Position retainers (F) according to the specified positions of covers (A).
- 4. Insert screws (D) through retainers (G).
- 5. Place connector (H), retainers (F), retainers (G), and screws (D) on one of covers (A).
- 6. Place the other cover (A).
- 7. Secure covers (A) using screws (B) and nuts (E). Note that tightening the screws excessively can damage the covers.



Communications (RS-232C interface)

Before connecting the communication cables, thoroughly read "Usage Notes" (p.7).

8.1 Interface Overview and Features

The communications interface can be used to control the instrument and acquire data.

Refer to the section that is relevant to your application.

- To control the instrument with commands
- To create a control program
- "
 - "8.4 Controlling the Instrument and Acquiring Data with Commands" (p. 119)
- To acquire measured values without using commands

"8.3 Automatically Exporting Measured Values at the Ends of Tests (Data output function)" (p.117)

Communications time

- There may be a delay in display processing depending on the frequency and nature of any communications processing performed.
- The data transfer time must be added when communicating with a controller.
 The RS-232C transfer time can be approximated with the following formula, where the transfer speed (baud rate) is N bps using 1 start bit, 8 data bits, no parity, 1 stop bit, for a total of 10 bits.
 Transfer time T [1 character/sec.] = Baud rate N [bps]/10 [bits]
 Since measured values are 11 characters in length, the transfer time for 1 piece of data is 11/T.

Since measured values are 11 characters in length, the transfer time for 1 piece of data is 11/T. (Example) For a 9,600 bps connection, 11/(9600/10) = Approximately 11 ms

Output Queue and Input Buffer

Output Queue

Response messages are stored in the output queue until read by the controller. The output queue is also cleared in the following circumstances:

- Power on
- Query Error

The output queue capacity of the instrument is 64 bytes. If response messages overflow the buffer, a query error is generated and the output queue is cleared.

Input Buffer

The input buffer capacity of the instrument is 256 bytes. More than 256 bytes of data will not be accepted.

Ensure that the no command ever exceeds 256 bytes.

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8.2 Using the RS-232C Interface

ACAUTION



 To avoid damage to the instrument, do not short connectors or output components or input voltage.

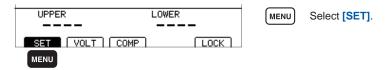


 To avoid electric shock or damage to the instrument, turn off the instrument before connecting or disconnecting the RS-232C interface connectors.

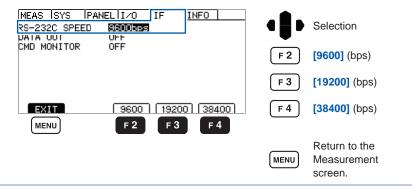
Setting communications conditions

Make the following instrument settings.

1 Open the Settings screen.



Select the interface transfer speed (baud rate) for [RS-232 SPEED].



The transfer speed (baud rate) setting may not be usable with some computers due to a large margin of error. In this case, switch to a slower setting.

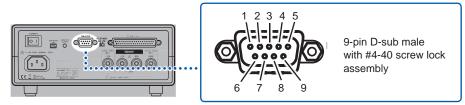
Set the controller (computer or PLC, etc.).

Make sure to set the controller as shown below.

- Start-stop synchronization
- Transfer speed: 9,600 bps / 19,200 bps / 38,400 bps (Set to match the instrument setting.)
- Stop bit: 1Data length: 8Parity check: NoneFlow control: None

Connecting the RS-232C cable

Connect the RS-232C cable to the RS-232C connector. When connecting the cable, be sure to tighten the connector in place with screws.



Rear panel

To connect the instrument to a controller (DTE), use a $\underline{\text{crossover cable}}$ compatible with the connectors on the instrument and the controller.

The I/O connector is a terminal (DTE) configuration.

This instrument uses pin numbers 2, 3, and 5. Other pins are not connected.

Die No	Sign	al nam	е	Cional	Domonico	
Pin No.	Common	EIA	JIS	Signal	Remarks	
1	DCD	CF	CD	Carrier detect	Not used	
2	RxD	BB	RD	Receive data		
3	TxD	ВА	SD	Transmit data		
4	DTR	CD	ER	Data terminal ready	ON level (+5 to +9 V) fixed	
5	GND	AB	SG	Signal ground		
6	DSR	CC	DR	Data set ready	Not used	
7	RTS	CA	RS	Request to send	ON level (+5 to +9 V) fixed	
8	CTS	СВ	CS	Clear to send Not used		
9	RI	CE	CI	Ring indicator	Not used	

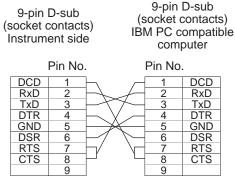
8

Using the RS-232C Interface

When connecting the instrument with a computer

Use a crossover cable with 9-pin D-sub (socket contacts) connectors.

Crossover wiring



Recommended cable: Hioki 9637 RS-232C Cable (9pin-9pin/1.8 m)

When connecting a controller with a 25-pin D-sub port

Use a crossover cable with a 9-pin D-sub (socket contacts) and a 25-pin D-sub (pin contacts) connector.

As in the figure shown below, the RTS and CTS pins are shorted and crossed to the DCD in the other connector.

oin D-si nstrum					sub ma ler side	
	Pin No.		-	Pin No.		
DCD	1	\vdash				
RxD	2	\vdash	\dashv	2	TxD	
TxD	3	\vdash	—	3	RxD	
DTR	4	<u> </u>	\neg	4	RTS	
GND	4 5	\vdash	Щ	5	CTS	
DSR	6	$\vdash \setminus \setminus$	\neg	6	DSR	
RTS	7	\vdash \vdash	\neg	7	GND	
CTS	8	\vdash	-	8	DCD	
	9	\	$\overline{}$	20	DTR	

Recommended cable: Hioki 9638 RS-232C Cable (9pin-25pin/1.8 m)

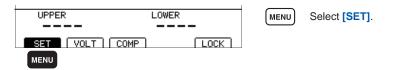
The combination of a dual 25-pin D-sub (pin contacts) cable and a 9-pin to 25-pin adapter cannot be used.

8.3 Automatically Exporting Measured Values at the Ends of Tests (Data output function)

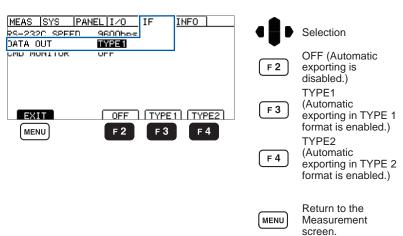
When a test is completed, the instrument can send measured values automatically as data to a computer via the RS-232C interface.

If the START key is pressed with TYPE 1 or TYPE 2 selected, do not send any commands to the instrument until the computer receives the measured values. Doing so may cause measured values to be sent twice.

1 Open the Settings screen.



Set [DATA OUT] to [ON].



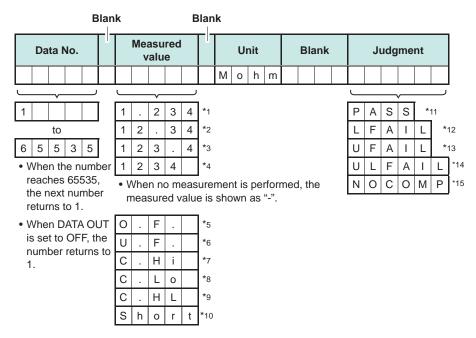
Automatically Exporting Measured Values at the Ends of Tests (Data output function)

Preparing connected equipment (computer, PLC, or others)

Set the equipment to the receive standby state. For a computer, start up the application software and set it to the receive standby state.

Data output example

TYPE1



- *1 The range is 2 $M\Omega$
- *2 The range is 20 $M\Omega$
- *3 The range is 200 $M\Omega$
- *4 The range is 2000/4000 $M\Omega$
- *5 Overflow
- *6 Underflow
- *7 Fail result for the contact check on the HIGH side
- *8 Fail result for the contact check on the LOW side

- *9 Fail result for the contact check on both the HIGH and LOW sides
- *10 Fail result for the short circuit check
- *11 PASS judgment
- *12 L.FAIL judgment
- *13 U.FAIL judgment
- *14 Judgment is not possible
- *15 Judgment is not performed

TYPE2

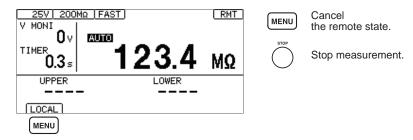
Data is output using the response format for the :MEASure? query. (Refer to "8.5 Data Format Table" (p. 122))

8.4 Controlling the Instrument and Acquiring Data with Commands

For communications commands and query notation, refer to "8.6 Command Reference" (p.123). When creating programs, the communications monitor function can be used to display commands and responses on the Measurement screen.

Remote and local states

During remote control operation, **[RMT]** is displayed on the Measurement screen and all operation keys except for the **MENU** and **STOP** keys are disabled.



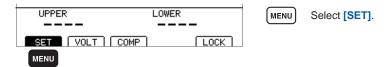
When the **MENU** key is pressed, the remote state is cancelled and the key operation is enabled.

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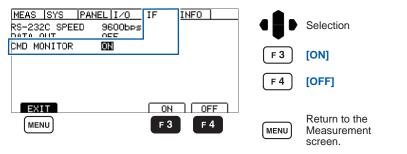
Displaying communications commands (Communications monitor function)

The communications monitor function can be used to display communications commands and query responses on the screen.

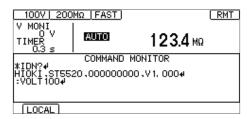
7 Open the Settings screen.



Set [CMD MONITOR] to [ON].



3 The communications command is displayed.



Messages displayed in the communications monitor and their meanings

If an error occurs during command execution, the following information is displayed.

- Command error (improper command, improper argument format, etc.)
- > #CMD ERROR
- · Argument out of range
- > #PARAM ERROR
- Execution error
- > #EXE ERROR

The approximate location of the error is also displayed.

Argument error (1E-3 is out of range)

- > :TIMer 1E-3
- > #^ PARAM ERROR
- Spelling error (:SPED FAST instead of :SPEED FAST)
- > :SPED FAST
- > #^ CMD ERROR

IMPORTANT

 If an illegal code is received, the character code is displayed in hexadecimal notation enclosed in "<>".

For example, the character 0xFF is displayed as <FF>, and 0x00 as <00>. If only hexadecimal characters like this are displayed, check the communications conditions or lower the communications speed.

If an RS-232C error occurs, the following information is displayed.

Overrun error (signal lost) #Overrun Error
Break signal received #Break Error
Parity error #Parity Error
Framing error #Framing Error

When these messages are displayed, check the communications conditions or lower the communications speed.

• When a series of consecutive commands are sent, the error position may shift.

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8.5 Data Format Table

Measured value

2 MΩ range	0.000E+06 to 4.000E+06	4 digits + decimal point
20 MΩ range	1.90E+06 to 9.99E+06	3 digits + decimal point
	10.00E+06 to 40.00E+06	4 digits + decimal point
200 MΩ range	19.0E+06 to 99.9E+06	3 digits + decimal point
	100.0E+06 to 400.0E+06	4 digits + decimal point
2000 MΩ range	190E+06 to 999E+06	3 digits
	1000E+06 to 4000E+06	4 digits
4000 MΩ range	190E+06 to 999E+06	3 digits
	1000E+06 to 9990E+06	4 digits
Over Flow	9999E+06	4 digits
Under Flow	0000E+06	4 digits
Error ^{*1}	0000E+10	4 digits

^{*1} When a contact check error, short circuit check error, or output voltage error occurs; otherwise no data are found.

Comparator upper/lower limit values

2 MΩ or less	0.000E+06 to 2.000E+06	4 digits + decimal point
20 MΩ or less	2.01E+06 to 9.99E+06	4 digits + decimal point
ZO IVIQ2 OF less	10.00E+06 to 20.00E+06	4 digits + decimal point
200 MΩ or less	20.1E+06 to 99.9E+06	4 digits + decimal point
200 MILT OF TESS	100.0E+06 to 200.0E+06	4 digits + decimal point
Over 200 MΩ	201E+06 to 999E+06	4 digits + decimal point
Over 200 MIZ2	1000E+06 to 9990E+06	4 digits

Test duration timer

0.045 s to 999.999 s (resolution 0.001 s)

Response time timer

0.005 s to 999.999 s (resolution 0.001 s)

Command reference description

Syntax :MOHM:RANGe <data>

Reference

Specifies the syntax for the command.

<>

Specifies the description of the message data (text or numerical parameter). A response is returned in capital letters for a text parameter. Numerical parameter:

NRf: Format including NR1, NR2, and NR3. NR1: Integer data (example: +12, -23, 34)

NR2: Decimal data (example: +1.23, -23.45, 3.456)

NR3: Floating decimal point index data (example: +1.0E-2, -2.3E+4)

<data> 2 M / 20 M / 200 M / 2000 M / 4000 M / AUTO (text data)

Reference

Explains parameter data.

Example Set to 200 $M\Omega$ range.

PC>:MOHM:RANGe 200M

Reference

Example of the use of the command

PC> indicates a command from the computer.

ST5520> indicates a response from the ST5520.

voltage

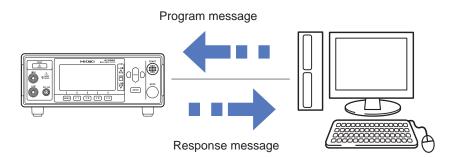
Error

An execution error occurs if the 2000 $\text{M}\Omega$ range is executed when the test voltage is between 25 V and 99 V.

Reference

Explains the error.

ce :he error.



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Command list

Classification	Command	Function	
Specialized	*CLS	Clears event resister	p.126
command	*ESR?	Queries event status resister	p.126
	*IDN?	Queries equipment ID	p.127
	*RST	Resets equipment	p.127
Testing status	:STARt	Starts a test	p.127
	:STOP	Ends a test	p.127
	:STATe?	Queries testing status	p.128
Measurement result	:MEASure?	Queries measured value	p.128
	:MEASure:COMParator?	Queries judgment result	p.129
	:MEASure:RESult?	Queries measured value and judgment result	p.129
	:MEASure:CLEar	Clears measured value and judgment result	p.130
Voltage setting	:VOLTage	Sets test voltage	p.130
	:VOLTage?	Queries test voltage	p.130
Resistance range	:MOHM:RANGe	Sets resistance range	p.130
	:MOHM:RANGe?	Queries resistance range	p.131
Measurement speed	:SPEed	Sets measurement speed	p.131
	:SPEed?	Queries measurement speed	p.131
Timer	:TIMer	Sets test duration	p.131
	:TIMer?	Queries test duration	p.132
	:DELay	Sets response time	p.132
	:DELay?	Queries response time	p.132
Comparator	:COMParator:LIMit	Sets comparator upper/lower limit value	p.133
	:COMParator:LIMit?	Queries comparator upper/lower limit value	p.133
	:COMParator:MODE	Sets comparator test mode	p.133
	:COMParator:MODE?	Queries comparator test mode	p.134
	:COMParator:BEEPer	Sets judgment beep sound	p.134
	:COMParator:BEEPer?	Queries judgment beep sound	p. 134
Contact check	:CONTactcheck	Sets contact check function	p.135
	:CONTactcheck?	Queries contact check function	p.135
	:CONTactcheck:RESult?	Queries the contact check result	p.135

Classification	Command	Function	
Short circuit check	:SHORtcheck	Sets short circuit check function	p.136
	:SHORtcheck?	Queries short circuit check function	p.136
	:SHORtcheck:TIME	Sets the short circuit check time	p.136
	:SHORtcheck:TIME?	Queries the short circuit check time	p.137
	:SHORtcheck:TIME :MONItor?	Queries the short circuit check execution time	p.137
	:SHORtcheck:RESult?	Queries the short circuit check result	p.137
Key beep sound	:KEY:BEEPer	Sets key beep sound	p.138
	:KEY:BEEPer?	Queries key beep sound	p.138
Double action	:DOUBleaction	Sets double action	p.138
	:DOUBleaction?	Queries double action	p.138
LCD	:DISPlay:CONTrast	Sets LCD contrast	p.139
	:DISPlay:CONTrast?	Queries LCD contrast	p.139
	:DISPlay:BACKlight	Sets LCD backlight	p.139
	:DISPlay:BACKlight?	Queries LCD backlight	p.139
Power frequency	:SYSTem:LFRequency	Sets power frequency	p.140
	:SYSTem:LFRequency?	Queries power frequency	p.140
Save/Load	:PANel:LOAD	Loads test conditions	p.140
	:PANel:SAVE	Saves test conditions	p.140
	:PANel:SAVE?	Queries if conditions saved with designated number are to be saved	p.141
	:PANel:NAME	Sets panel name	p.141
	:PANel:NAME?	Queries panel name	p.141
	:PANel:CLEar	Deletes panel	p.142
Analog output	:AOUT:RANGe	Sets analog output	p.142
	:AOUT:RANGe?	Queries analog output	p.142
Switched probe operation	:PROBe	Sets switched probe operation mode	p.142
	:PROBe?	Queries switched probe operation mode	p.143
TEST signal OFF	:IO:SIGNal	Sets TEST signal timing	p.143
timing	:IO:SIGNal?	Queries TEST signal timing	p.143
Interlock	:IO:ILOCK	Sets interlock status	p.144
	:IO:ILOCK?	Queries interlock status	p.144
Key lock	:SYSTem:KLOCk	Sets key lock status	p.144
	:SYSTem:KLOCk?	Queries key lock status	p.145

Classification	Command	Function	
Command header ON/OFF function	:HEADer	Sets response command header ON/OFF	p.145
	:HEADer?	Queries response command header ON/OFF	p.145
Communications	:SYSTem:LOCal	Resets remote state	p.146

Lower-case characters in the commands are technically optional. The commands are case-insensitive.



Clears event status resister (ESR).

Syntax *CLS

*ESR?

Returns the value of the event status register (ESR) as a decimal notation numerical value in NR1 format 0 to 7 (<data>) and then clears the event status register status.

No command header is included in response. The register is configured as shown in the table below. When an error occurs, it returns data as a numerical value calculated in decimal notation based on each error.

Syntax	*ESR?
Response	<data>0 to 7 (NR1 numerical data)</data>
Example	When all of bit0 (Command error), bit1 (Execution error), bit2 (Query error) are set as 1. PC>*ESR? ST5520>7

Event status register

Decimal notation	_	_	_	_	_	4	2	1
Bit	bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
Status	Unused	Unused	Unused	Unused	Unused	QYE	EXE	CME

QYE: Query error, EXE: Execution error, CME: Command error

*IDN?

Queries manufacturer's name, model name, and software version. No header command is included in response.

First field: Manufacturer's name Second field: Model name Third field: Serial number Forth field: Software version

Syntax	*IDN?
Response	<data></data>
Example	PC>*IDN? ST5520>HIOKI,ST5520,000012345,V1.00

*RST

Resets the instrument setting. When this command is executed during a test, the test is stopped and the setting is reset. The saved test conditions are also cleared.

To reset the setting, refer to "5.10 Default Setting List" (p.73).

Syntax	*RST
Example	To execute resetting PC>*RST

:STARt

Starts a test.

Syntax	:STARt
Example	PC>:STARt
Error	When this command is executed during tests, an execution error occurs. When this command is executed while the interlock function is activated, an execution error occurs.

:STOP

Ends a test.

Syntax	:STOP	
Example	PC> •STOP	

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:STATe?

Returns the instrument status in numerical data (<data>). No command header is included in response.

Syntax	:STATe?
Response	<data></data>
<data></data>	0 to 2 (NR1 numerical data) 0: Stopped, 1: Testing, 2: Discharging
Example	To query the status (during tests) PC>:STATE? ST5520>1

:MEASure?

Queries the measured value. When this command is received during a test, the measured value is returned in NR3 numerical data (<data>).

After the test is completed, the measured value when the previous test was completed is returned. No command header is included in response.

Syntax	:MEASure?	
Response	<data></data>	
<data></data>	Measured value "8.5 Data Format Table" (p.122)	
Example	To query the measured value (when the measured value is 123.4 MΩ) PC>:MEASure? ST5520>123.4E+06	

:MEASure:COMParator?

Queries judgment result.

When this command is received during tests, the judgment result is returned in text data (<data>). When the comparator function is OFF, OFF is always returned as a judgment result.

When no judgment is made, NOCOMP is returned. When the response time timer is ON, DELAY is returned.

After the test is completed, the judgment result when the previous test was completed is returned.

No command header is included in response.

Syntax	:MEASure:COMP	arator?
Response	<data></data>	
<data></data>	Judgment result	OFF /NOCOMP /DELAY /PASS /UFAIL /LFAIL / ULFAIL (text data) OFF: The judgment function is OFF. NOCOMP: No judgment is made. DELAY: The response time timer is ON. PASS: Within judgment standard UFAIL: Upper limit value ≤ Measured value LFAIL: Lower limit value ≥ Measured value ULFAIL: Judgment is not possible (the upper or lower limit value exceeds the range)
Example	To query the judgr PC>:MEASure:0 ST5520> PASS	ment result (when the judgment result is PASS) COMParator?

:MEASure:RESult?

Queries measured value and judgment result.

During a test the measured value and then the judgment result at the time this command is received are returned as <measured value> and then <judgment result> in data (<data1>, <data2>).

After the test is completed, the measured value and judgment result when the previous test was completed are returned.

No command header is included in response.

Syr	ntax	:MEASure:RESult?	
Resp	onse	<data1>,<data2></data2></data1>	
<dat< td=""><td>ta1></td><td>Measured value</td><td>"8.5 Data Format Table" (p.122)</td></dat<>	ta1>	Measured value	"8.5 Data Format Table" (p.122)
<dat< td=""><td>ta2></td><td>Judgment result:</td><td>OFF /NOCOMP /DELAY /PASS /UFAIL /LFAIL / ULFAIL (text data)</td></dat<>	ta2>	Judgment result:	OFF /NOCOMP /DELAY /PASS /UFAIL /LFAIL / ULFAIL (text data)
Exar	mple	To query the measured value and judgment result (when the measured value is 123.4 MΩ and the judgment result is PASS) PC>:MEASure:RESult? ST5520>123.4E+06,PASS	

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:MEASure:CLEar

Clears measured value and judgment result.

The status is changed so that no judgment has been made.

Syntax	:MEASure:CLEar
Example	To clear the measured value and judgment result PC>:MEASure:CLEar

:VOLTage

Sets the test voltage.

When the testing start command, :STARt is sent sequentially after the test voltage is changed, a time of up to 500 ms is added until the test starts.

Syntax	:VOLTage <data></data>	
<data></data>	Test voltage	25 to 1000 (NR1 numerical data)
Example	To set the test voltage to 100 V PC>:VOLTage 100	

:VOLTage?

Queries the test voltage. The test voltage is returned in NR1 numerical data (<data>).

Syntax	:VOLTage?	
Response	:VOLTAGE <data> or simply <data></data></data>	
<data></data>	Test voltage 25 to 1000 (NR1 numerical data)	
Example	To query the test voltage (when the test voltage is 100 V) PC>:VOLTAGE? ST5520>:VOLTAGE 100 (when the :HEADEr command is ON) ST5520>100 (when the :HEADEr command is OFF)	

:MOHM:RANGe

Sets the resistance range.

Syntax	:MOHM:RANGe <data></data>
<data></data>	2 M / 20 M / 200 M / 2000 M / 4000 M / AUTO (text data)
Example	To set to 200 MΩ range PC>:MOHM:RANGe 200M
Error	An execution error occurs if the 2000 $M\Omega$ range is set when the test voltage is 25 V to 99 V.

:MOHM:RANGe?

Queries the resistance range. The resistance range is returned in text data (<data>).

Syntax	:MOHM:RANGe?	
Response	:MOHM:RANGE <data> or simply <data></data></data>	
<data></data>	2 M / 20 M / 200 M / 2000 M / 4000 M / AUTO (text data)	
Example	To query the resistance range (when the resistance range is 200 MΩ) PC>:MOHM:RANGE? ST5520>:MOHM:RANGE 200M	
	(when the :HEADer command is ON) ST5520>200M (when the :HEADer command is OFF)	

:SPEed

Sets the measurement speed to FAST/SLOW.

Syntax	:SPEed <data></data>
<data></data>	FAST/SLOW (text data)
Example	To set the measurement speed to FAST PC>:SPEed FAST

:SPEed?

Queries the measurement speed. The measurement speed setting FAST/SLOW is returned in text data (<data>).

Syntax	:SPEed?
Response	SPEED <data> or simply <data></data></data>
<data></data>	FAST/SLOW (text data)
Example	To query the measurement speed (when the speed is set to FAST) PC>:SPEEd? ST5520>:SPEED FAST (when the :HEADEr command is ON) ST5520>FAST (when the :HEADEr command is OFF)

:TIMer

Sets the test duration.

Set 0.0 when the test duration is not to be set. During a test, the test is stopped and the test duration is set.

Syntax	:TIMer <data></data>
<data></data>	Test duration (unit: second) 0.0 and 0.045 to 999.999 (resolution 0.001), (NR2 numerical data) "8.5 Data Format Table" (p.122)
Example	To set the test duration to 10 seconds PC>:TIMer 10

:TIMer?

Queries the test duration setting.

The test duration is returned in NR2 numerical data (<data>). 0.0 is returned when the test duration timer is not to be used.

Syntax	:TIMer?	
Response	:TIMER <data> or simply <data></data></data>	
<data></data>	Test duration (unit: second) 0.0 and 0.045 to 999.999 (resolution 0.001), (NR2 numerical data) "8.5 Data Format Table" (p.122)	
Example	To query the test duration setting (when the test duration is 10 seconds) PC>:TIMer? ST5520>:TIMER 10.000 (when the :HEADEr command is ON) ST5520>10.000 (when the :HEADEr command is OFF)	

:DELay

Sets the response time. Set 0.0 when the response time is set to auto (AUTO). If a test is being performed, it is stopped and the response time is set.

Syntax	:DELay <data></data>
<data></data>	Response time (unit: second) 0.0 and 0.005 to 999.999 (resolution 0.001) (NR2 numerical data) "8.5 Data Format Table" (p.122)
Example	To set the response time to 5.5 seconds PC>:DELay 5.5

:DELay?

Queries the response time setting. The response time is returned in NR2 numerical data (<data>). 0.0 is returned when the response time is set to auto (AUTO).

Syntax	:DELay?	
Response	:DELAY <data> or simply <data></data></data>	
<data></data>	Response time (unit: second) 0.0 and 0.005 to 999.999 (resolution 0.001) (NR2 numerical data) "8.5 Data Format Table" (p.122)	
Example	To query the response time (when the response time is 5.5 seconds) PC>:DELay? ST5520>:DELAY 5.500 (when the :HEADer command is ON) ST5520>5.500 (when the :HEADer command is OFF)	

:COMParator:LIMit

Sets the comparator upper/lower limit values.

Set the upper/lower limit values in <data1>, <data2> (NR3 numerical data).

Set the values to make the upper limit value ≥ lower limit value.

When the upper limit value is less than the lower limit value, an execution error occurs.

Syntax	:COMParator:LIMit <data1>,<data2></data2></data1>
<data1></data1>	OFF (text data) or comparator upper limit value (NR3 numerical data)
<data2></data2>	OFF (text data) or comparator lower limit value (NR3 numerical data)
Example	To set the upper limit value to 15 M Ω and the lower limit value to 10 M Ω PC> :COMParator:LIMit 15E+06,10E+06

:COMParator:LIMit?

Queries the comparator upper/lower limit values.

The upper/lower limit values are returned in <data1>, <data2> (NR3 numerical data).

Syntax	:COMParator:LIMit?	
Response	:COMPARATOR:LIMIT <data1>,<data2> or simply <data1>,<data2></data2></data1></data2></data1>	
<data1></data1>	OFF (text data) or comparator upper limit value (NR3 numerical data)	
<data2></data2>	OFF (text data) or comparator lower limit value (NR3 numerical data)	
Example	To query the upper/lower limit values (when the upper limit value is set to 15 MΩ and the lower limit to 10 MΩ) PC>:COMParator:LIMIT? ST5520>:COMPARATOR:LIMIT 15.00E+06,10.00E+06 (when the :HEADer command is ON) ST5520>15.00E+06,10.00E+06 (when the :HEADer command is OFF)	

:COMParator:MODE

Sets the comparator test mode.

Syntax	:COMParator:MODE <data></data>
<data></data>	CONTinue, PASSstop, FAILstop, SEQuence (text data)
Example	To set the test mode to FAIL STOP PC>:COMParator:MODE FAILstop

:COMParator:MODE?

Queries the comparator test mode.

The test mode is returned in text data (<data>).

Syntax	:COMParator:MODE?	
Response	:COMPARATOR:MODE <data> or simply <data></data></data>	
<data></data>	CONTINUE/PASSSTOP/FAILSTOP/SEQUENCE (text data)	
Example	To query the comparator test mode (when the test mode is FAIL STOP) PC>:COMParator:MODE? ST5520>:COMPARATOR:MODE FAILSTOP	
	(when the :HEADer command is ON) ST5520>FAILSTOP (when the :HEADer command is OFF)	

:COMParator:BEEPer

Sets the beep sound at the time of comparator judgment and at the end of the timed duration.

Syntax	:COMParator:BEEPer <data></data>
<data></data>	PASS/FAIL/OFF/END (text data)
Example	To set to beep at FAIL judgment PC>:COMParator:BEEPer FAIL

:COMParator:BEEPer?

Queries the beep sound setting at the time of comparator judgment and at the end of the timed duration.

The beep sound setting is returned in text data (<data>).

Syntax	:COMParator:BEEPer?	
Response	:COMPARATOR:BEEPER	<data> or simply <data></data></data>
<data></data>	PASS/FAIL/OFF/END (tex	rt data)
Example	To query the beep sound setting at the time of judgment (when the beeper sounds at FAIL judgment) PC>:COMParator:BEEPer? ST5520>:COMPARATOR:BEEPER FAIL	
	ST5520>FAIL	(when the :HEADer command is ON) (when the :HEADer command is OFF)

:CONTactcheck

Sets the contact check function ON/OFF.

Syntax	:CONTactcheck <data></data>
<data></data>	ON/OFF (text data) ON: The contact check function is enabled. OFF: The contact check function is disabled.
Example	To set the contact check function to ON PC>:CONTactcheck ON

:CONTactcheck?

Queries the contact check function ON/OFF setting. The setting is returned in text data (<data>).

Syntax	:CONTactcheck?	
Response	:CONTACTCHECK <data> or simply <data></data></data>	
<data></data>	ON/OFF (text data) ON: The contact check function is enabled. OFF: The contact check function is disabled.	
Example	To query the contact check function (when the contact check function is enabled) PC>:CONTactcheck? ST5520>:CONTACTCHECK ON (when the :HEADer command is ON) ST5520>ON (when the :HEADer command is OFF)	

:CONTactcheck:RESult?

Queries the contact check result.

No command header is included in the response.

	Syntax	:CONTactcheck:RESult?
	Response	<data></data>
LFAIL: Contact check error on the LOW sid		NOCHK: Not checked yet
	Example	To query the contact check result (when the result is fail on the HIGH side) PC>:CONTactcheck:RESult? ST5520>:HFAIL

:SHORtcheck

Sets the short circuit check function ON/OFF.

Syntax	:SHORtcheck <data></data>	
<data></data>	 ON/OFF (text data) ON: The short circuit check function is enabled. OFF: The short circuit check function is disabled. 	
Example	To set the short circuit check function to ON PC>:SHORtcheck ON	

:SHORtcheck?

Queries the short circuit check function ON/OFF setting. The setting is returned in text data (<data>).

Syntax	:SHORtcheck?	
Response	:SHORTCHECK <data> or simply <data></data></data>	
<data></data>	ON/OFF (text data) ON: The short circuit check function is enabled. OFF: The short circuit check function is disabled.	
Example	To query the short circuit check function (when the short circuit check function is enabled) PC>:SHORtcheck? ST5520>:SHORTCHECK ON (when the :HEADer command is ON) ST5520>ON (when the :HEADer command is OFF)	

:SHORtcheck:TIME

Sets the short circuit check time.

Set 0.0 when the short circuit check time is set to auto (AUTO).

Syntax	:SHORtcheck:TIME <data></data>	
<data></data>	Short circuit check time (unit: second) 0.0 and 0.010 to 1.000 (resolution 0.001) (NR2 numerical data)	
Example To set the short circuit check time to 0.5 seconds PC>:SHORtcheck:TIME 0.5		

Queries the short circuit check time.

The short circuit check time is returned in NR2 numerical data (<data>). 0.000 is returned when the short circuit check time is set to auto (AUTO).

Syntax	:SHORtcheck:TIME?	
Response	:SHORTCHECK:TIME <data> or simply <data> (NR2 numerical data)</data></data>	
<data></data>	Short circuit check time (unit: second) 0.000 and 0.010 to 1.000 (resolution 0.001)	
Example	To query the short circuit check time (when the short circuit check execution time is 0.017 seconds) PC>:SHORtcheck:TIME? ST5520>:SHORTCHECK:TIME 0.017 (when the :HEADer command is ON) ST5520>0.017 (when the :HEADer command is OFF)	

:SHORtcheck:TIME:MONItor?

The short circuit check execution time when the short circuit check time is set to 0.0 (AUTO) is returned in NR2 numerical data (<data>). 0.000 is returned when the short circuit check function is set to OFF or MANUAL.

No command header is included in the response.

Syntax	:SHORtcheck:TIME:MONItor?
Response	<data> (NR2 numerical data)</data>
<data></data>	Short circuit check execution time (unit: second) 0.000 to 1.000 (resolution 0.001)
Example	To query the short circuit check execution time (when the short circuit check execution time is 0.017 seconds) PC>:SHORtcheck:TIME:MONItor? ST5520>0.017

:SHORtcheck:RESult?

Queries the short circuit check result. The result is returned in text data (<data>). No command header is included in the response.

Syntax	:SHORtcheck:RESult?
Response <data> <data> NOCHK/PASS/FAIL (text data) NOCHK: Not checked yet PASS: No error FAIL: Short circuit error</data></data>	

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:KEY:BEEPer

Sets the key beep sound ON/OFF.

Syntax	:KEY:BEEPer <data></data>
<data></data>	ON/OFF (text data)
Example	To set the key beeper to sound PC> :KEY:BEEPER ON

:KEY:BEEPer?

Queries the key beep sound ON/OFF setting. The beep sound ON/OFF setting is returned in text data (<data>).

Syntax	:KEY:BEEPer?	
Response	:KEY:BEEPER <data> or simply <data></data></data>	
<data> ON/OFF (text data)</data>		
Example	To query the key beep sound ON/OFF setting (when the setting is ON) PC>:KEY:BEEPER? ST5520>:KEY:BEEPER ON (when the :HEADEr command is ON) ST5520>ON (when the :HEADEr command is OFF)	

:DOUBleaction

Sets the double action function ON/OFF.

Syntax	:DOUBleaction <data></data>	
<data> ON/OFF (text data) ON: The double action function is enabled. OFF: The double action function is disabled.</data>		
Example To set the double action function to ON PC>:DOUBleaction ON		

:DOUBleaction?

Queries the double action function ON/OFF setting. The setting is returned in text data (<data>).

Syntax	:DOUBleaction?	
Response : DOUBLEACTION <data> or simply <data></data></data>		or simply <data></data>
<data></data>	ON/OFF (text data) ON: The double action function is enabled. OFF: The double action function is disabled.	
Example	To query the double action function setting (when the setting is ON) PC>:DOUBLeaction? ST5520>:DOUBLEACTION ON (when the :HEADer command is ON) ST5520>ON (when the :HEADer command is OFF)	

:DISPlay:CONTrast

Sets the LCD contrast.

Syntax	:DISPlay:CONTrast <data></data>
<data></data>	0 to 100 (NR1 numerical data)
Example	To set the contrast to 60 PC> :DISPlay:CONTrast 60

:DISPlay:CONTrast?

Queries the LCD contrast. The setting is returned in NR1 number data (<data>).

Syntax	:DISPlay:CONTrast?	
Response	:DISPLAY:CONTRAST <	data> or simply <data></data>
<data></data>	0 to 100 (NR1 numerical data)	
Example	To query the contrast (wh PC>:DISPlay:CONTrast ST5520>:DISPLAY:CON	st?
	ST5520>60	(when the :HEADer command is OFF)

:DISPlay:BACKlight

Sets the LCD backlight brightness.

0 can be set only from communications. The LCD backlight turns off when 0 is set.

Syntax	:DISPlay:BACKlight <data></data>
<data></data>	0 to 3 (NR1 numerical data)
Example	To set the brightness to 2 PC>:DISPlay:BACKlight 2

:DISPlay:BACKlight?

Queries the LCD backlight brightness. The setting is returned in NR1 number data (<data>).

Syntax	:DISPlay:BACKlight?	
Response	:DISPLAY:BACKLIGHT <	data> or simply <data></data>
<data></data>	0 to 3 (NR1 numerical data	a)
Example	To query the LCD backlight brightness (when the brightness setting is 2) PC>:DISPlay:BACKlight? ST5520>:DISPLAY:BACKLIGHT 2	
	ST5520>2	(when the :HEADer command is ON) (when the :HEADer command is OFF)

:SYSTem:LFRequency

Sets the power frequency.

When AUTO is set, 50 Hz and 60 Hz are automatically identified.

Syntax	:SYSTem:LFRequency <data></data>
<data></data>	AUTO/50/60 (text data) AUTO: The power frequency is automatically identified. 50: Power frequency 50 Hz 60: Power frequency 60 Hz
Example	To set the power frequency to 60 Hz PC>:SYSTem:LFRequency 60

:SYSTem:LFRequency?

Queries the power frequency setting. The setting is returned in NR1 number data (<data>).

Syntax	:SYSTem:LFRequency?	
Response	:SYSTEM:LFREQUENCY <	data> or simply <data></data>
<data></data>	AUTO/50/60 (text data)	
Example	To query the power frequency setting (when the power frequency is 60 Hz) PC>:SYSTEm:LFRequency? ST5520>:SYSTEM:LFREQUENCY 60	
	ST5520>60	(when the :HEADer command is ON) (when the :HEADer command is OFF)

:PANel:LOAD

Loads the test conditions with the specified number. During a test, the test is stopped and the test conditions are loaded.

Syntax	:PANel:LOAD <data></data>
<data></data>	Test condition number 1 to 10 (NR1 numerical data)
Example	To load No. 3 test conditions PC>:PANel:LOAD 3

:PANel:SAVE

Saves the test conditions with the specified number.

Syntax	:PANel:SAVE <data></data>
<data></data>	1 to 10 (NR1 numerical data)
Example	To save as No. 3 PC>:PANel:SAVE 3

:PANel:SAVE?

Queries if the test conditions are saved with the specified number. Whether the test conditions are saved is returned in numerical data (<data2>). No command header is included in response.

5	Syntax	:PANel:SAVE? <datal></datal>	
<	data1>	Test condition number 1 to 10 (NR1 numerical data)	
Re	esponse	<data2></data2>	
<	data2>	0 to 1 (NR1 numerical data) 1: The test conditions are saved. 0: The test conditions are not saved.	
E:	xample	To query if the test conditions are saved as No. 3 (when the test conditions are saved as No. 3) PC>: PANel:SAVE? 3 ST5520>1	

:PANel:NAME

Changes the saved test condition name.

The test condition name is enclosed in "" (double quotation marks).

Syntax	:PANel:NAME <datal>,<data2></data2></datal>
<data1></data1>	Test condition number 1 to 10 (NR1 numerical data)
<data2></data2>	Test condition name (text data: up to ten half-width characters)
Example	To set the test condition name for Test condition 1 to "TEST1" PC> :PANel:NAME 1,"TEST1"

:PANel:NAME?

Queries the test condition name. The specified number is returned in NR1 number data (<data1>) and the test condition name is returned in text data (<data2>).

Syntax	:PANel:NAME? <data1></data1>	
Response	:PANEL:NAME <data1>,<data2> or simply <data1>,<data2></data2></data1></data2></data1>	
<data1></data1>	Test condition number 1 to 10 (NR1 numerical data)	
<data2></data2>	Test condition name (text data: up to ten half-width characters)	
Example	To query the test condition name for Test condition 1 (when the test condition name is "TEST1") PC>:PANEL:NAME 1,"TEST1"	
	(when the :HEADer command is ON) ST5520>1,"TEST1" (when the :HEADer command is OFF)	

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:Panel:CLEar

Deletes the test conditions.

Syntax	:Panel:CLEar <data1></data1>
<data1></data1>	Test condition number 1 to 10 (NR1 numerical data)
Example	To delete Test condition 1 PC>:Panel:CLEar 1

:AOUT:RANGe

Sets whether the analog output is to be output in all measurement resistance ranges or in each range display area.

Syntax	:AOUT:RANGe <data></data>
<data></data>	FULL/EACH (text data) FULL: Output in all measurement resistance ranges EACH: Output in each range display area
Example	To set to output in all measurement resistance ranges PC> AOUT: RANGE FULL

:AOUT:RANGe?

Queries the analog output setting.

The FULL or EACH setting is returned in text data (<data>).

Syntax	:AOUT:RANGe?		
Response	:AOUT:RANGE <data> or simply <data></data></data>		
<data></data>	FULL/EACH (text data) FULL: Output in all measurement resistance ranges EACH: Output in each range display area		
Example	To query the output method PC>:AOUT:RANGE? ST5520>:AOUT:RANGE FT ST5520>FULL	ULL (when the :HEADer command is ON) (when the :HEADer command is OFF)	

:PROBe

Sets the 9299 Switched Probe operation mode.

During a test, the test is stopped and the operation mode is set.

Syntax	:PROBe <data></data>
<data></data>	CONTinue/TRIGger (text data) CONTinue: Continuous mode TRIGger: Trigger mode
Example	To set continuous mode PC>: PROBe CONTinue

:PROBe?

Queries the 9299 Switched Probe operation mode setting. The continuous or trigger setting is returned in text data (<data>).

Syntax	:PROBe?	
Response	:PROBE <data> or simply <data></data></data>	
<data></data>	CONTINUE/TRIGGER (text data) CONTINUE: Continuous mode TRIGGER: Trigger mode To query the operation mode (when the operation mode setting is CONTINUE) PC>:PROBE? ST5520>:PROBE CONTINUE (when the :HEADer command is ON) ST5520>CONTINUE (when the :HEADer command is OFF)	
Example		

:IO:SIGNal

Sets the timing for the TEST signal to return from LOW to HIGH when a test is completed.

Syntax	:IO:SIGNal <data></data>
<data></data>	SLOW/FAST (text data)
Example	To set the timing to FAST PC> :IO:SIGNal FAST

:IO:SIGNal?

Queries the timing for the TEST signal to return from LOW to HIGH when a test is completed. The SLOW or FAST setting is returned in text data (<data>).

Syntax	:IO:SIGNal?		
Response	:IO:SIGNAL <data> or simply <data></data></data>		
<data></data>	SLOW/FAST (text data)		
Example	To query the timing (when the setting is FAST) PC>:IO:SIGNal? ST5520>:IO:SIGNAL FAST (when the :HEADEr command is ON) ST5520>FAST (when the :HEADEr command is OFF)		

Command Reference

:IO:ILOCk

Sets the interlock function.

Syntax	IO:ILOCk <data></data>
<data></data>	ON/OFF (text data) ON: The interlock function is enabled. OFF: The interlock function is disabled.
Example	To set the interlock function to ON PC>IO:ILOCk ON

:IO:ILOCk?

Queries the interlock function setting. The ON or OFF setting is returned in text data (<data>).

Syntax	IO: ILOCk?		
Response	IO:ILOCK <data> or simply <data></data></data>		
<data></data>	ON/OFF (text data) ON: The interlock function is enabled. OFF: The interlock function is disabled.		
Example	To query the interlock function setting (when the setting is ON) PC>IO:ILOCk? ST5520>IO:ILOCK ON (when the :HEADEr command is ON) ST5520>ON (when the :HEADEr command is OFF)		

:SYSTem:KLOCk

Sets the key lock.

Syntax	:SYSTem:KLOCk <data></data>
<data></data>	ON/OFF (text data) ON: The key lock is set. OFF: The key lock is cancelled.
Example	To set the key lock PC>:SYSTem:KLOCk ON

:SYSTem:KLOCk?

Queries the key lock setting. The ON or OFF setting is returned in text data (<data>).

Syntax	:SYSTem:KLOCk?			
Response	:SYSTEM:KLOCK <da< td=""><td colspan="3">:SYSTEM:KLOCK <data> or simply <data></data></data></td></da<>	:SYSTEM:KLOCK <data> or simply <data></data></data>		
<data></data>	ON/OFF (text data) ON: The key lock is set. OFF: The key lock is cancelled.			
Example	To query the key lock PC>:SYSTEM:KLOCK ST5520>:SYSTEM:KI			

:HEADer

Sets whether the command the instrument received is added to the reply data or not. When the power is turned on, the setting is reset to OFF.

Syntax	:HEADer <data></data>
<data></data>	ON/OFF (text data) ON: With a command header OFF: Without a command header
Example	To set to ON PC>:HEADer ON

:HEADer?

Queries the setting of whether the command the instrument received is added to the head of the reply data or not. The ON/OFF setting is returned in text data (<data>).

5	Syntax	:HEADer?		
Re	sponse	:HEADER <data> or simply <data></data></data>		
<	:data>	ON/OFF (text data) ON: With a command header OFF: Without a command header		
E	xample	To query whether the command header is added or not (when the setting is ON) PC>:HEADER? ST5520>:HEADER ON (when the :HEADER command is ON) ST5520>OFF (when the :HEADER command is OFF)		

Command Reference

:SYSTem:LOCal

Changes the communications remote state back to the local state. The key operation is enabled.

Syntax :SYSTem:LOCal

Example To cancel the remote state

PC>:SYSTem:LOCal

9 Specifications

Environment and safety

Indoors, pollution degree 2, altitude up to 2,000 m (6,562-ft.)			
-10°C to 50°C (-14°F to 122°F), 80% RH or less (no condensation)			
0°C to 40°C (32°F to 104°F), 80% RH or less (no condensation)			
1.62 kV AC (sensed current 10 mA) for 1 minute Between all power terminals and protective ground			
he			
1 hour (Continuous short circuit state)			
Approx. 215W \times 80H \times 166D mm (8.46"W \times 3.15"H \times 6.54"D) Excluding protrusion			

Output (output accuracy)

Output voltage	25 V to 1000 V (arbitrary) Display The set voltage is displayed at the top of the instrument screen.	
Output voltage accuracy	1% of set voltage ±2 V	
Voltage resolution	1 V	
Voltage monitoring accuracy	2% of output voltage ±1 V (Less than 1.8 mA at a constant voltage)	

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Charge (measurement) 1.8 mA current **Short circuit current** Less than 2.0 mA **Analog output** Not isolated against the power supply protective ground terminal and isolated against the measurement terminals. Output voltage: Switching between FULL and EACH 1. FULL 0 to 4 V is output in all measured resistance ranges. Output voltage Measurement voltage Displayed resistance (DC) 25 V ≤ V < 100 V 0 V to 4 V $0.000~\text{M}\Omega$ to 200.0 $\text{M}\Omega$ 100 V ≤ V < 500 V $0.000~\text{M}\Omega$ to 2000 $\text{M}\Omega$ 0 V to 4 V 500 V ≤ V ≤ 1000 V 0 V to 4 V $0.000~\text{M}\Omega$ to 4000 $\text{M}\Omega$ 4 V Over. F All measurement voltages Under. F 0 V 2. EACH 0 to 4 V is output according to each resistance range. Output voltage Displayed resistance Resistance range (DC) 2 ΜΩ 0.000 $\text{M}\Omega$ to 2.000 $\text{M}\Omega$ 0 V to 4 V 20 ΜΩ 0.38 V to 4 V 1.90 $M\Omega$ to 20.00 $M\Omega$ $200~\text{M}\Omega$ 19.0 $\text{M}\Omega$ to 200.0 $\text{M}\Omega$ 0.38 V to 4 V $2000 \ M\Omega$ 190 $\text{M}\Omega$ to 2000 $\text{M}\Omega$ 0.38 V to 4 V $(100 \text{ V} \le \text{V} < 500 \text{ V})$ $4000~\text{M}\Omega$ 190 $\text{M}\Omega$ to 4000 $\text{M}\Omega$ 0.19 V to 4 V $(500 \text{ V} \le \text{V} \le 1000 \text{ V})$ Over. F 4 V All resistance ranges Under. F 0 V **Analog output** ±2% f.s. accuracy Load resistance 1 $M\Omega$ or more

Resistance range composition

Manual range (2 M Ω , 20 M Ω , 200 M Ω , 2000 M Ω , 4000 M Ω), Auto range

Range display

The set range is displayed at the top of the screen.

Rated measurement voltage	Resistance range	Display range	Resolution
	2 MΩ range	0.000 MΩ to 4.000 MΩ	0.001 MΩ
25 V ≤ V < 100 V	20 MΩ range	1.90 MΩ to 40.00 MΩ	0.01 ΜΩ
	200 MΩ range	19.0 MΩ to 400.0 MΩ	0.1 ΜΩ
	2 MΩ range	0.000 MΩ to 4.000 MΩ	0.001 ΜΩ
100 V ≤ V < 500 V	20 MΩ range	1.90 MΩ to 40.00 MΩ	0.01 ΜΩ
100 V S V < 500 V	200 MΩ range	19.0 MΩ to 400.0 MΩ	0.1 ΜΩ
	2000 MΩ range	190 MΩ to 4000 MΩ	1 ΜΩ
	2 MΩ range	0.000 M Ω to 4.000 M Ω	0.001 MΩ
500 V ≤ V ≤ 1000 V	20 MΩ range	1.90 MΩ to 40.00 MΩ	0.01 ΜΩ
300 V S V S 1000 V	200 MΩ range	19.0 MΩ to 400.0 MΩ	0.1 ΜΩ
	4000 MΩ range	190 MΩ to 9990 MΩ	1 ΜΩ

^{*} To display a value of 1000 M Ω or over, the last digit is fixed at 0 and the resolution is 10 M Ω . When the measured value exceeds the display range, "Over.F" or "Under.F" is displayed.

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accuracy	Rated measurement voltage	Guaranteed accuracy range	Basic accuracy
		0.000 M Ω to 2.000 M Ω	. 20/ rdg . E dat
	25 V ≤ V < 100 V	1.90 M Ω to 20.00 M Ω	±2% rdg. ±5 dgt.
		19.0 M Ω to 200.0 M Ω	±5% rdg.
		0.000 M Ω to 2.000 M Ω	±2% rdg. ±5 dgt.
	100 V ≤ V < 500 V	1.90 M Ω to 20.00 M Ω	
		19.0 M Ω to 2000 M Ω	±5% rdg.
		0.000 M Ω to 2.000 M Ω	
		1.90 M Ω to 20.00 M Ω	±2% rdg. ±5 dgt.
	500 V ≤ V ≤ 1000 V	19.0 M Ω to 200.0 M Ω	
		190 M Ω to 4000 M Ω	±5% rdg.
		4010 MΩ to 9990 MΩ	±25% rdg.

Input

Our welfers land	4400 V DC (pacitive palents and)
Over voltage input	1100 V DC (positive polarity only)
protection	
P	

Guaranteed accuracy

Conditions of guaranteed accuracy	Warming-up time 15 minutes or more
Temperature and humidity for guaranteed accuracy	23°C \pm 5°C (73°F \pm 9°F), 80% RH or less, no condensation
Temperature coefficient	Add 0.1 × Basic accuracy × (T-23) T: Operating temperature (°C
Accuracy warranty period	1 year

Response time

Definition of response time	No-judgment time	
Response time function		
Setting range	AUTO, 0.005 s (5 ms) to 999.999 s	
Operation	Comparator judgment is not performed after measurement starts until the response time elapses. The timer counts down along with the test duration timer (Test voltage is generated).	
Resolution	1 ms	

Functions

Voltage monitoring		
Update speed	Same as that of resistance display	
Contact check		
Method	4-terminal (For 2-terminal, the comparator upper and lower limit values are used.)	
Operation	Contact check is performed for each sampling and a contact error occurs if a faulty contact is detected. (Obtained by using RS command or EXT.I/O)	
Sampling	Sampling varies depending on the measurement speed setting. FAST: 100 ms, SLOW: 500 ms	
Comparator		
Display	The upper and lower limit values are always displayed.	
Judgment	UPPER_FAIL, PASS, LOWER_FAIL, UL_FAIL UPPER_FAIL Measured value ≥ Upper limit value PASS Upper limit value > Measured value > Lower limit value LOWER_FAIL Measured value ≤ Lower limit value UL_FAIL When no judgment can be made.	
Beep sound	ON/OFF (based on the judgment beep sound setting)	
Display	The LEDs for PASS, UPPER_FAIL, LOWER_FAIL are lit. Both UPPER_FAIL and LOWER_FAIL are lit at the same time for UL_ FAIL. "" is displayed when the comparator is set to OFF.	
Judgment output	Based on the test mode. Both UPPER_FAIL and LOWER_FAIL are output at the same time for UL_FAIL. The last test result is held.	

Operation	No judgment is performed for forced termination (STOP key, STOP signal). However, a judgement result is output when forced termination judgment mode is set. (No judgment is performed if the STOP key is pressed before one measurement, with an elapsed time of less than 45 ms, is not completed.) No LED display or EXT.I/O signal output.
Memory function	
Items to be saved	Rated measurement voltage, comparator upper and lower limit values (including comparator ON/OFF), test mode, judgment beep sound, test duration, response time (no-judgment time), resistance range (ON/OFF of auto range, including resistance range for fixed range), and measurement speed
Number of memory data units	Maximum of 10 patterns (can be saved and loaded)
Measurement speed	
FAST	Sampling: 30 ms/time
SLOW	Sampling: 500 ms/time
Data hold	Automatically holds the measurement value display at the time of measurement completion, judgment result display, EXT.I/O judgment result output, and analog output.

Test mode	 Switch a mode selecting from continuous mode, PASS STOP mode, FAIL STOP mode, or forced termination judgment mode. Continuous mode Measurement is performed for the specified test duration, judgment is performed for each measurement, the judgment result is output, and the output voltage is cut off. The displayed measured value and judgment result display are held as they are at the end of a test. PASS STOP mode A test is completed when a PASS judgment is made and the output voltage is cut off. The displayed measured value and PASS display are held as they are at the end of the test. FAIL STOP mode A test is completed when a FAIL judgment is made and the output voltage is cut off. The displayed measured value and FAIL display are held as they are at the end of the test. Forced termination judgment mode The judgment result based on the upper and lower limit values is displayed after the setting time elapsed or at the time of STOP is input (key, RS command, or EXT.I/O). Judgment result is output on the display, via RS command, or via EXT.I/O. The displayed measured value and judgment result display are held as they are at the end of a test.
Double action	
Operation	The START key is enabled only for 1 s after the STOP key is pressed.
Key lock function	
Reset means	Hold down the [UNLOCK] key (for 1 s) when the key lock function is enabled.
Display	[LOCK] is displayed at the top of the screen when the key lock function is enabled. (The START key and STOP key are enabled.)
Interlock function	
Display	[LOCK] is displayed at the top of the screen when the interlock function is enabled.
Operation	No key operations are enabled. No tests can be started via EXT.I/O or RS command.

Discharge and remaining voltage warning	Any charge remaining in equipment to be measured is automatically discharged inside of the instrument when the testing is completed. The TEST lamp blinks during discharge and turns off when the voltage between the measurement terminals falls under 10 V \pm 3 V. During a test: Blinking interval 250 ms During discharge: Blinking interval 500 ms
Judgment beep soun	d
Setting	PASS (beeps when a PASS judgment is made), FAIL (beeps when a FAIL judgment is made), END (beeps at the end of a test), or OFF (no beep sound) can be selected.
Key beep sound	ON/OFF can be switched.
System reset	The system is initialized.
Short circuit check	Before a test, apply approx. 2 V to 4 V to equipment to be measured and check for short circuits. No short circuit: A test starts. Short circuit: No tests start. A short circuit error is output.
Short circuit check time automatic measurement function	This function can be performed only when the short circuit check setting is ON. • AUTO setting A test starts after the automatic short circuit check has been completed. The time required for the short circuit check is displayed on the screen. When it takes 0.5 s or more, the short circuit check will time out. • MANUAL setting The time to be taken for the short circuit check can be set freely. Setting range: 0.010 s to 1.000 s
Communications monitor function	RS commands and query responses are displayed on the screen.

External interface

The EXT.I/O mode can be switched between NPN (current sink output) and PNP (current source output).

The switching is set by using the switch on the back of the instrument.

(1) Input signal

· Common specifications

Photocoupler-isolated are supported)	, no voltage	contact input (current sink output and current source output
Input ON	Residual v	voltage 1 V or less (input ON current 4 mA (reference value))
Input OFF	OPEN (cutoff current 100 μA or less)	
Response time	Edge	1.0 ms _{MAX}

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• Signals

START	Starts a test and generates output voltage.
STOP	Ends a test and cuts off output voltage.
INTERLOCK	Open when the interlock function is enabled, short circuit when the interlock function is disabled.
LOAD0 to LOAD3	Selects a test condition from saved test conditions.

(2) Output

• Common specifications

Photocoupler-isolated, open drain output (non-polar)	
Maximum load voltage	30 V DC $_{\mbox{\tiny MAX}}$ Residual voltage 1 V or less (load current 50 mA) / 0.5 V or less (load current 10 mA)
Maximum output current	50 mA _{MAX} /ch

• Signals

0	
PASS	The output transistor is ON when comparator PASS judgment is made.
UPPER FAIL	The output transistor is ON when comparator UPPER FAIL judgment is made. The output transistor is ON when comparator UL_FAIL judgment is made.
LOWER FAIL	The output transistor is ON when comparator LOWER FAIL judgment is made. The output transistor is ON when comparator UL_FAIL judgment is made.
TEST	The output transistor is ON during a test. The output transistor is ON or OFF during discharge depending on the TEST signal OFF timing setting.
ERR	The output transistor is ON at the time of a contact check error, short circuit error, output voltage error judgment
(ST5520-01 only)	
DP0 to DP2	Decimal point output 3 bits (p.87)
BCD0 to BCD15	BCD output 4 digits, 16 bits (p.87)

• Internal power output

Output voltage	Sink current output compatible 5.0 V±10% Source current output compatible -5.0 V±10%, 100 mA _{MAX}
Isolation	Floating from protective ground potential and measurement circuit
Isolation rating	Terminal to ground voltage 50 V DC, 33 V AC $_{\mbox{\tiny RMS}},$ and 46.7 V AC $_{\mbox{\tiny PEAK}}$ or less
ISO.5 V	Internal power supply

ISO.COM Internal GND

• External interface pin arrangement list (p.84)

(3) TEST signal OFF timing setting

After a test, timing for the TEST signal output transistor to turn OFF from ON can be set.

FAST	The TEST signal turns OFF immediately after a test is completed without waiting for the voltage between the measurement terminals to drop.
SLOW	The TEST signal turns OFF after the voltage between the measurement terminals drops below 10 V \pm 3 V.

Refer to "Test duration accuracy" (p.151).

EXT.SW (not isolated against the power supply protective ground terminal and isolated against the measurement terminals)

The switch signal line plug of the 9299 Switched Probe is connected.

The operation mode can be switched between two modes, CONT and TRIG (the instrument settings have priority).

Continuous (CONT) mode	Measurement is performed only while the 9299 switch is being pressed.
Trigger (TRIG) mode	A test starts and stops every time the 9299 switch is pressed.

RS-232C (not isolated against the power supply protective ground terminal and isolated against the measurement terminals)

RMT is displayed at the top of the screen during communications and any keys other than the LOCAL key and STOP key are disabled.

Remote control and measured value output can be performed.

Output data setting: OFF/TYPE 1/TYPE 2

• TYPE1

Output: Measured value + judgment

• TYPE2

Output: Measured value (index display 000.0E+06)

(Same as :MEASure? query) (p. 122)

(1) RS-232C interface

Transfer method	Communications: Full duplex Synchronization: Start-stop synchronization		
Baud rate	9,600 bps (default) / 19,200 bps / 38,400 bps		
Data length	8 bits		
Parity	None		
Stop bit	1 bit		

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Message terminator (delimiter)	Receiving: CR+LF, CR Transmitting: CR+LF			
Flow control	None			
Electrical specifications	Input voltage levels 5 to 15 V: ON, -15 to -5 V: OFF Output voltage levels 5 to 9 V: ON, -9 to -5 V: OFF			
Connector	Interface connector pinout (9-pin D-sub, pin contacts, with #4-40 attachment screws) The I/O connector is a terminal (DTE) configuration. Recommended cables: 9637 RS-232C Cable (for PC) 9638 RS-232C Cable (for 25-pin D-sub connector)			

Operating code: ASCII codes

(2) Maintenance terminal

Communications cannot be performed. Used for upgrading software.

Other specifications

Display

Display parameter	Resistance value, voltage value, test duration, upper limit value (comparator), lower limit value (comparator), set voltage, set range, measurement speed, panel name, status display (remote, key lock), short circuit check time			
Contrast adjustment	0 to 100 (resolution: 5)			
Backlight	0, 1, 2, 3 (1: Dark, 2: Standard, 3: Bright, 0: OFF, OFF can be set only via communications.)			
Resistance	Display range 0.000 M Ω to 9990 M Ω Measured resistance value 4 digits, Max. 9990 counts			
Voltage	Display range 0 V to 1020 V Voltage value 4 digits, Max. 1020 counts			
Comparator	4 digits			
Timer	6 digits			
Lamp	TEST, PASS, U.FAIL, L.FAIL			
Switch/Key				
Front (keys)	START, STOP, ENTER, MENU, F1 to F4, and cursor keys			
Rear (switches)	Power switch ON/OFF, EXT.I/O mode switch (NPN/PNP)			

Measurement range, measurement speed, test mode, beep sound, contact check, external interface setting, memory (saving and deleting

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MENU keys

test conditions), and other settings.

Key combination	Initialization (Turn on the power while pressing the MENU + Up keys.) Interlock cancellation (Turn on the power while pressing the MENU + Down keys.)
	DOWN Reys.)

Enabled/disabled input list

The following table shows the status (enabled/disabled) of the keys, switched probe, EXT.I/O, and RS command input. "\scriv" indicates enabled and "-" indicates disabled. Some combinations of status can occur simultaneously, however, the disabled status has priority.

Input		Switched Probe 9299			
Status	START	STOP	UNLOCK/LOCAL	Others	START/STOP
The EXT.I/O STOP signal is LOW.	-	✓	✓	✓	-
The EXT.I/O INTERLOCK signal is LOW.	-	√	-	-	_
Remote	_	✓	√ (Resets the remote.)	-	✓
Key lock	✓	✓	√ (Resets the lock.)	-	√
TEST	-	✓	-	-	✓

Input	EXT.I/O			RS command		
Status	START	STOP	Others *1	:START	:STOP	Others
The EXT.I/O STOP signal is LOW.	-		✓	Execution error	✓	✓
The EXT.I/O INTERLOCK signal is LOW.	_	✓	✓	_	✓	✓
Remote	✓	✓	✓	✓	✓	✓
Key lock	✓	✓	✓	✓	✓	✓
TEST	-	√	√*²2	Execution error	✓	✓*3

^{1:} The interlock is enabled during panel load operation.
2: The test is stopped when panel is loaded during the test.
3: Some commands stop a test.

External terminal (No switching between the measurement terminals on the front panel and those on the rear panel)

Front	Measurement terminals (HIGH, LOW), EXT.SW terminal
Rear	Measurement terminals (HIGH, LOW), EXT.I/O terminal, contact check terminals, RS-232C connector, analog output terminal, USB connector (maintenance terminal)

Accessories

Instruction manual	1
Power cord	
EXT.I/O connector (pin contacts)	1
EXT.I/O connector cover	et

Options

L2200	lest Lead
L9257	Connection Cord
9299	Switched Probe
9094	Output Cord (analog output)
9637	RS-232C Cable (9pin-9pin/1.8 m)
9638	RS-232C Cable (9pin-25pin/1.8 m)

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Maintenance and Service

10.1 Maintenance

MARNING



Some of the internal components carry high voltage, which is very hazardous. Customers are not allowed to modify, disassemble, or repair the instrument. Doing so may cause fire, electric shock, or injury.

Calibrations

IMPORTANT

Periodic calibration is necessary in order to ensure that the instrument provides correct measurement results of the specified accuracy.

The calibration frequency varies depending on the status of the instrument or installation environment. We recommend that the calibration frequency be determined in accordance with the status of the instrument or installation environment and that you request that calibration be performed periodically.

Transporting

- When shipping the instrument, use the packing materials used when the instrument was delivered.
- Pack the instrument so that it is not damaged during shipping and include a
 description of existing damage. Hioki cannot be responsible for damage that occurs
 during shipping.

Cleaning

- To clean the instrument and optional equipment, wipe them gently with a soft cloth moistened with water or mild detergent.
- Wipe the display gently with a soft, dry cloth.

IMPORTANT

Never use solvents such as benzene, alcohol, acetone, ether, ketones, thinners, or gasoline. They can deform and discolor the instrument.

Disposal

Handle and dispose of the instrument and optional equipment in accordance with local regulations.

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Maintenance

Replacement parts and lifetime

Some of the parts used for this instrument may deteriorate due to an extended period of use.

It is recommended to replace the parts so that the instrument can be used for a long period of time.

Contact your authorized Hioki distributor or reseller for replacement parts. The lifetime of the parts varies depending on the operating environment and frequency of use. The recommended replacement timing is not guaranteed.

Part name	Recommended replacement timing	Remarks/Conditions
Electrolytic capacitor	Approx. 10 years	The board on which the capacitor is installed is to be replaced.
LCD backlight	Approx. 10 years	When the backlight is used for 24 hours/ day at 25 \pm 5°C and 50 \pm 10% RH.

10.2 Troubleshooting

When a malfunction of the instrument is suspected, check the information in "Before sending the instrument for repair" and then, if necessary, contact your authorized Hioki distributor or reseller.

Before sending the instrument for repair

Symptom	Solution	Reference
An error is displayed in the display screen.	When an error appears in the display, refer to Error display and solutions (p. 166).	-
Even after short circuit of the probe, the measured value does not appear.	If the measured value is not displayed when the probe is short circuited, the fuse may have blown or been damaged. Contact your authorized Hioki distributor or reseller.	-

Measurement

Symptom	Cause and solution	Reference
The measurement value does not appear.	An appropriate measurement range may not be automatically defined. Extend the test duration.	p.39
The voltage is not output.	The probe wires may be broken. Use the contact check function or check the probe using a tester.	p.56
The set voltage is not output.	Check the resistance of the load. The measurement current is limited to less than 2.0 mA. The voltage cannot rise to the set voltage with the load carrying a current of 2.0 mA or more. Example) If the set voltage is 500 V and the resistance load is 100 k Ω , the voltage rises only to 200 V.	-
The comparator judgment result is wrong.	The resistance range may not be set to the range appropriate for the lower limit value. Refer to the resistance measurement specifications and change the range accordingly.	p.36
	The probe wires may be broken. Use the contact check function or check the probe using a tester.	-
	The measurement terminals may be connected to both the front and rear terminals. When the measurement terminals are connected to both the terminals, accurate measurement cannot be performed.	p.24

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Troubleshooting

Symptom	Cause and solution	Reference
Unstable measured values	The power frequency setting may not be appropriate. Change the power frequency according to the customer environment.	p.71
	A load containing capacitance components may be connected. It may take time for the measured value to stabilize depending on the capacitance components. Extend the test duration.	
	The measurement cable is long and the measured value may be affected by the wiring capacity.	p.Appx.6
	Noise may be causing the unstable measured value.	р. Аррх.7

External Control

Symptom	Cause and solution	Reference
Communications	Check the RS-232C transfer speed.	p.114
cannot be performed smoothly.	Check the commands that are sent and received using the communications monitor function. The areas where command and execution errors occur can be checked.	p.120
Control cannot be performed with EXT.I/O.	The wiring may be wrong. The connectors may be disconnected. The pin number may be wrong. ISO_COM terminal wiring NPN/PNP setting Contact (or open collector) control (not controlled by voltage) Power supply to EXT.I/O (It is not necessary to supply power to the instrument.)	p.81
	Check the input and output signals using the EXT.I/O test function.	p.103
A test does not start.	Check the pulse width of the START and TEST signals. Refer to the timing chart.	p.88

Others

Symptom	Cause and solution	Reference
The power does not turn on.	The power may not be supplied. Check the power cord. Check that the facility breaker is on. Turn on the power switch (rear side).	-
	The power voltage and frequency may not be correct. Check the power rating. (100 V to 240 V, 50/60 Hz)	-

Troubleshooting

Symptom	Cause and solution	Reference
The key operation cannot be performed.	[LOCK] is displayed.When the key lock function is set to ON, disable the function.	p.65
	When the interlock function is set to ON, switch it to OFF. To disable the interlock function, turn on the power while holding down the MENU key and down key. Otherwise, send the communication command, :IO:ILOCk OFF.	p.106
	While a LOAD signal is input, the instrument enters the key lock state, accepting no key operations.	p.86
	[RMT] is displayed. Reset the remote.	p.119
	[LOCK] is displayed. Release the interlock.	
	How to release the interlock Turn on the power while pressing the MENU + Down keys. The interlock can also be released using the ":IO:ILOCk OFF" communication command.	p.106
The COMP lamp does not turn on.	When the measured value is displayed, the upper or lower limit value may not be set. Set the upper or lower limit value.	p.44
	When the measured value is not displayed, an appropriate measurement range may not be automatically defined. Extend the test duration.	p.39
A contact check error occurs.	The probe wires may be broken. Check the probe using a tester.	-
	The contact resistance between the measurement terminal and contact check terminal may be high.	-
	The equipment to be measured may not be in contact. Check the wiring again.	-
[Output Voltage Error] is displayed.	A voltage that is higher than the set test voltage may be output. A malfunction may have occurred. Contact your authorized Hioki distributor or reseller.	-
	A voltage that is higher than the set voltage may be input during the test. Check that the equipment to be measured has been fully discharged. Example) If the voltage applied during a pressure test is not fully released when the pressure test is performed before an insulation resistance test is performed.	-

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Error display and solutions

The following messages are displayed on the screen when there is a problem with the instrument or measurement.

If repair is required, contact your authorized Hioki distributor or reseller.

- If any damage is suspected, check "Troubleshooting" first and then contact your authorized Hioki distributor or reseller.
- If an error is displayed in the LCD display and repair is required, contact your authorized Hioki distributor or reseller.

D	isplay	Meaning	Solution	Reference
ContHL		Contact check error	Check the wiring of the measurement cable for the contact check.	p.56
			Check the contact check function.	p.29
ContHi		HIGH side contact check error	Check the wiring of the measurement cable for the HIGH side contact check.	p.56
			Check the contact check function.	p.29
ContLo		LOW side contact check error	Check the wiring of the measurement cable for the LOW side contact check.	p.56
			Check the contact check function.	p.29
Short		Short circuit check error	The equipment to be measured may be short-circuited. Check the equipment to be measured.	p.60
ERR:001	RR:001 LOW limit is higher than UPP limit. The upper limit value cannot be set because the lower limit value is greater than the upper limit value.		Set the upper limit value so it is greater than the lower limit value.	p.44
		Double action error	The double action function is set to ON.	p.68
ERR:003	Delay time is longer than test time.	Test duration error	The response time is set longer than the test duration.	p.39

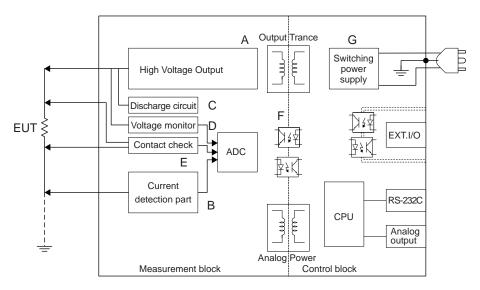
Troubleshooting

D	isplay	Meaning	Solution	Reference
ERR:004	Measurement aborted by interlock.	Interlock error	The test is canceled because the interlock function is activated during the test.	p.106
ERR:030	Command error.	Command error	Check that the command is correct.	-
ERR:031	Execution error. (Parameter error)	Execution error. The parameter setting is outside of the range.	Check that the parameter range is correct.	-
ERR:032	Execution error.	Execution error	Check that the command with an error does not fall under the execution error conditions.	-
ERR:090	ROM check sum error.	Program ROM check sum error	The instrument is malfunctioning. Send the instrument out for repair.	-
ERR:091	RAM error.	CPU RAM error	The instrument is malfunctioning. Send the instrument out for repair.	-
ERR:094	Output voltage error. Power off by rear power- sw.	Output voltage error. Turn off the power switch on the rear panel.	A voltage that is higher than the set test voltage may be output. Refer to "Troubleshooting" as well.	p.163
ERR:096	Backup data error.	Setting backup error	The settings have been initialized. Reset the measurement conditions, etc.	-
ERR:097	Power line detection error. Select power line cycle.	Power frequency detection error	Set the frequency according to the supply power.	p.71

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Appendix

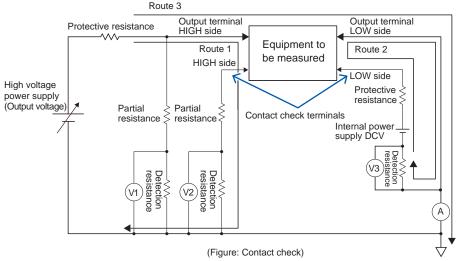
Appx. 1 Block Diagram



- With our unique technology, the ripple component in the DC voltage is reduced and DC voltage is output without overshoot. The DC voltage can be changed between 25 V and 1000 V in increments of 1 V resolution. (A)
- In order to conform to safety standard IEC61010, the short circuit current is controlled under 2.0 mA. (B)
- Any charge in the equipment to be measured can be released quickly. (C)
- The voltage monitor is operating any time in addition to during tests, the voltage between measurement terminals can always be monitored. (D)
- As a contact check circuit is installed and contacts are always monitored, the quality of an insulation resistance test can be improved. (E)
- An operational isolation structure of 1000 V DC with sufficient isolation performance is provided for the analog and digital units. (F)
- The auto-ranging 100-to-240 V switching power supply can provide stable measurements even in poor power quality environments. (G)

Appx

Appx. 2 Contact Check Function



A contact check is performed independently for the output terminal HIGH side and LOW side. The principle of a contact check is shown below.

Principle

HIGH side contact check:

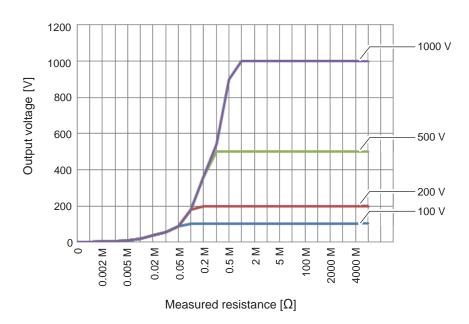
Using output voltage monitor V1 and contact check voltage monitor V2, the voltage of the measurement terminal is measured and whether the output voltage is reliably applied to the terminal is checked. (Route 1)

LOW side contact check:

Internal power supply (DCV) for a contact check on the LOW side and current (voltage) detector V3 are provided. A contact check is performed by V3 that detects the current from DCV flowing the electrode of the equipment to be measured. (Route 2)

As resistance is normally detected by Route 3, DCV for a contact check on the LOW side does not affect resistance measurements.

Appx. 3 Output Voltage and Measurement Resistance



Output voltage depends on measurement current 1.8 mA. If the equipment to be measured carries 1.8 mA or more, the voltage does not rise to the set output voltage.

Appx.

Appx. 4 Influence of Capacitive Load

Pure resistance is assumed in the instrument specifications, however, some capacitance components are contained in the equipment to be measured. The higher the resistance is (small detected current), the more variability the influence of a capacitive load causes.

Influence on output voltage rise

The charge current of the instrument is 1.8 mA (less than 20 mA).

If a capacitive load, such as a capacitor, is connected, the time required for the output voltage to rise is affected. The time is calculated as follows.

CV = it (C: Capacitance (F), V: Voltage (V), i: Current (A), t: Time (s))

Example: If a test voltage of 500 V is applied to a 1.0 μF capacitor, the time required for the

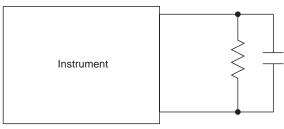
output voltage to rise to 500 V is approximately 0.28 s, calculated by (1.0 μF x 500 V)/1.8 mA.

If the equipment to be measured contains capacitive components, extend the test duration.

Repeat accuracy

Test condition: Connect and measure the resistance load and capacitive load in parallel. (See the figure below.)

(A film capacitor is used.)



Connection diagram

As the test data shows below, measurements were performed for each resistance range and variation in the average of 100 measurements was calculated. The measured values were obtained with the capacitor charged.

(Test duration: Max. 100 s)

FAST

Voltage Capacitance	25 V	50 V	100 V	250 V	500 V	1000 V
0.001 μF	±1.0%	±1.0%	±1.4%	±1.3%	±1.3%	±1.4%
0.01 μF	±1.5%	±1.4%	±2.7%	±1.7%	±1.8%	±3.7%
0.05 μF	±3.0%	±2.5%	±7.0%	±3.0%	±5.8%	±7.7%
0.1 μF	±5.8%	±4.5%	±14.0%	±6.8%	±11.5%	±53.0%

SLOW

Voltage Capacitance	25 V	50 V	100 V	250 V	500 V	1000 V
0.001 μF	±1.0%	±1.0%	±1.0%	±1.0%	±1.0%	±1.0%
0.01 μF	±1.2%	±1.0%	±1.6%	±1.2%	±1.8%	±1.5%
0.05 μF	±1.5%	±1.2%	±2.2%	±2.0%	±2.8%	±1.4%
0.1 μF	±2.0%	±1.6%	±3.8%	±2.0%	±3.0%	±8.6%

Variation may be different depending on the capacitor type.

Appx.

Appx. 5 Influence of Cable Length

When the instrument is incorporated in a production line or automated machine, the measurement cable may be extended. When the measurement cable is extended, measured values can be affected by coupling capacitance between cables or line noise. The level of influence on measured values when the measurement cable is extended is shown below.

For the influence of a capacitive load, refer to "Appx. 4 Influence of Capacitive Load" (p. Appx.4). For the influence of line noise, refer to "Appx. 6 Influence of Noise" (p. Appx.7).

Cable: UL1032 AWG18

Twisted wires 75 wires x ϕ 0.12 mm (extended optional L2200)

Instrument settings

Test voltage: 1000 VResistance range: $4000 \text{ M}\Omega$ range

Load: $3600 \text{ M}\Omega$ + cable coupling capacitance (approx. 250 pF)

Cable length Measurement speed	0.7 m	2 m	3 m	4 m
FAST	±0.1%	±0.4%	±0.7%	±0.9%
SLOW	±0.1%	±0.4%	±0.6%	±0.8%

The values above indicate the repeat accuracy.

Cautions for measurement cable wiring

- When the measurement cable is laid on a metal ground, the influence of noise can be reduced.
- When the measurement cable is extended, the influence of power line noise becomes more significant. Position the measurement cable away from the power line.
- Position the measurement cable away from any noise sources (motor, welder, inverter, etc.).

Appx. 6 Influence of Noise

When induction noise is caused by commercial power supply

Induction noise caused by a commercial power supply is generated by not only commercial power lines or power outlets but also by fluorescent lights and household electrical appliances. The noise caused by a commercial power supply depends on the frequency of the power supply and is generated at a frequency of 50 Hz or 60 Hz.

To reduce the influence of noise caused by the commercial power supply, a method for converting the integration time to the integral multiple of the power frequency is generally used. (Figure. Noise caused by commercial power supply)

The measurement speed of this instrument is FAST or SLOW. In a high resistance measurement, the measured value may not be stabilized. In such a case, reduce the measurement speed or take appropriate measures to reduce noise.

If the instrument is used with a power frequency setting of 60 Hz in a 50 Hz area, the measured value fluctuates even if the measurement speed is set so that the integration time becomes the integral multiple of the power frequency. Check the instrument power frequency setting.

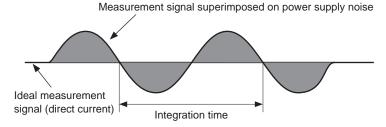


Figure. Noise caused by commercial power supply

Appx.

Influence of Noise

Influence of conductive noise

In addition to inductive noise superimposed on the equipment to be measured or measurement leads, there is conductive noise. Conductive noise indicates noise superimposed on a power line or control line, such as a USB, etc.

Various devices, including a motor, welder, inverter, etc. are connected to the power line. When these devices are in operation or every time they start and stop, current spikes are generated in the power supply. Due to the current spikes and power line wiring impedance, significant voltage spikes are generated in the power line and power ground line, which can affect measurement equipment.

Noise may be generated from the controller control line in the same manner. The noise from the controller power or the DC-DC converter inside the controller enters the measurement equipment through the USB or EXT.I/O wiring. (Figure. Conductive noise entry route)

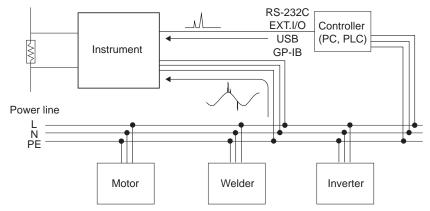


Figure. Conductive noise entry route

It is efficient to take measures for conductive noise by monitoring with the HIOKI 3145 Noise HiLogger. When the entry route is identified, taking the measures as shown in the figure below is effective.

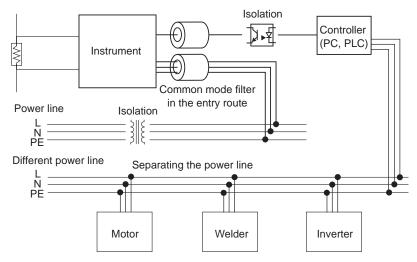


Figure. Measures for conductive noise

Separating the power line

It is desirable to prepare a different power line for the power system, welder, etc.

Inserting a common mode filter (EMI choke) in the entry route

Selecting and inserting several common mode filters with a high impedance level increases effectiveness.

Appx.

Appx. 7 Rack Mounting

By removing the screws on the bottom, this instrument can be installed in a rack mounting plate.

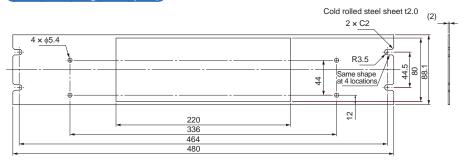
WARNING

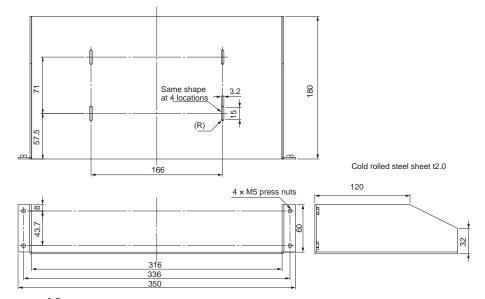
0

Observe the following precautions regarding the mounting screws to avoid instrument damage and electric shock accidents.

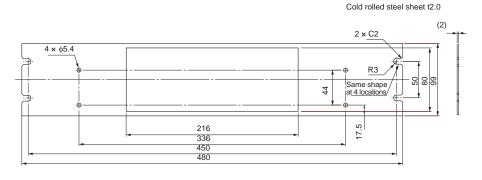
 When removing the Rack Mounting Plate to return the instrument to stand-alone use, replace the same screws that were installed originally. (Feet: M3 x 6 mm)

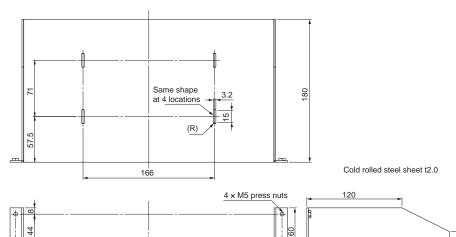
Rack Mounting Plate template diagram and installation procedure Rack Mounting Plate (EIA)





Rack Mounting Plate (JIS)



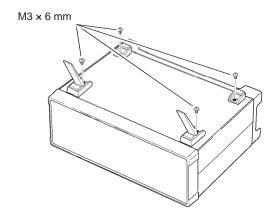


316 336 350

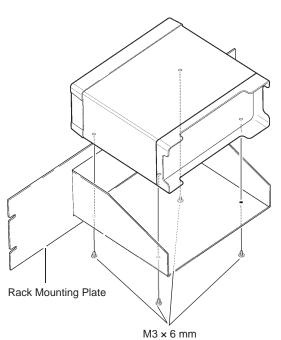
Appx.

Appx.**11**

Rack Mounting



Extend the legs on the bottom of the instrument and remove the four screws.



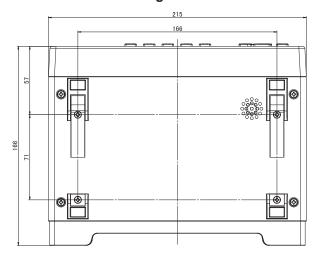
Affix the Rack Mounting Plate with the M3 x 6 mm screws.

IMPORTANT

When installing into the rack, support the installation with a commercially available support stand.

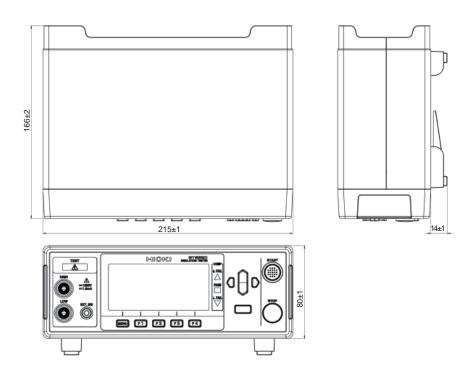
Rack Mounting

Screw location dimensional drawing





Appx. 8 Dimensional Diagram



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Ind.**1**

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Ind.**2**

Warranty Certificate

Model	Serial No.	Warranty period
		One (1) year from date of purchase (/)

This product passed a rigorous inspection process at Hioki before being shipped.

In the unlikely event that you experience an issue during use, please contact the distributor from which you purchased the product, which will be repaired free of charge subject to the provisions of this Warranty Certificate. This warranty is valid for a period of one (1) year from the date of purchase. If the date of purchase is unknown, the warranty is considered valid for a period of one (1) year from the product's date of manufacture. Please present this Warranty Certificate when contacting the distributor. Accuracy is guaranteed for the duration of the separately indicated guaranteed accuracy period.

- 1. Malfunctions occurring during the warranty period under conditions of normal use in conformity with the Instruction Manual, product labeling (including stamped markings), and other precautionary information will be repaired free of charge, up to the original purchase price. Hioki reserves the right to decline to offer repair, calibration, and other services for reasons that include, but are not limited to, passage of time since the product's manufacture, discontinuation of production of parts, or unforeseen circumstances.
- 2. Malfunctions that are determined by Hioki to have occurred under one or more of the following conditions are considered to be outside the scope of warranty coverage, even if the event in question occurs during the warranty period:
 - Damage to objects under measurement or other secondary or tertiary damage caused by use of the product or its measurement results
 - Malfunctions caused by improper handling or use of the product in a manner that does not conform with the provisions of the Instruction Manual
 - Malfunctions or damage caused by repair, adjustment, or modification of the product by a company, organization, or individual not approved by Hioki
 - d. Consumption of product parts, including as described in the Instruction Manual
 - Malfunctions or damage caused by transport, dropping, or other handling of the product after purchase
 - f. Changes in the product's appearance (scratches on its enclosure, etc.)
 - g. Malfunctions or damage caused by fire, wind or flood damage, earthquakes, lightning, power supply anomalies (including voltage, frequency, etc.), war or civil disturbances, radioactive contamination, or other acts of God
 - h. Damage caused by connecting the product to a network
 - i. Failure to present this Warranty Certificate
 - Failure to notify Hioki in advance if used in special embedded applications (space equipment, aviation equipment, nuclear power equipment, life-critical medical equipment or vehicle control equipment, etc.)
 - k. Other malfunctions for which Hioki is not deemed to be responsible

*Requests

- · Hioki is not able to reissue this Warranty Certificate, so please store it carefully.
- Please fill in the model, serial number, and date of purchase on this form.

13-09